

PRELIMINARY

WICED™ IEEE 802.11 a/b/g/n SoC with an Embedded Applications Processor

The Cypress CYW43903 embedded wireless system-on-a-chip (SoC) is uniquely suited for Internet-of-Things applications. It supports all rates specified in the IEEE 802.11 b/g/n specifications. The device includes an ARM Cortex-based applications processor, a single stream IEEE 802.11n MAC/baseband/radio, a power amplifier (PA), and a receive low-noise amplifier (LNA). It also supports optional antenna diversity for improved RF performance in difficult environments.

The CYW43903 is an optimized SoC targeting embedded Internet-of-Things applications in the industrial and medical sensor, home appliance markets. Using advanced design techniques and process technology to reduce active and idle power, the device is designed for embedded applications that require minimal power consumption and a compact size.

The device includes a PMU for simplifying system power topology and allows for direct operation from a battery while maximizing battery life.

Cypress Part Numbering Scheme

Cypress is converting the acquired IoT part numbers from Broadcom to the Cypress part numbering scheme. Due to this conversion, there is no change in form, fit, or function as a result of offering the device with Cypress part number marking. The Table 1 provides Cypress ordering part number that matches an existing IoT part number.

Table 1. Mapping Table for Part Number between Broadcom and Cypress

Broadcom Part Number	Cypress Part Number
BCM43903	CYW43903
BCM43903KUBG	CYW43903KUBG

Features

Application Processor Features

- ARM Cortex-R4 32-bit RISC processor.
- 1 MB of on-chip SRAM for code and data.
- An on-chip cryptography core
- 640 KB of ROM containing WICED SDK components such as RTOS and TCP/IP stack.
- 17 GPIOs supported.
- Q-SPI serial flash interface to support up to 40 Mbps of peak transfer.
- Support for UART (3), SPI or CSC master, interfaces.
 (Cypress Serial Control (CSC) is an I²C-compatible interface.)

Key IEEE 801.11x Features

- Single-band 2.4 GHz IEEE 802.11n compliant.
- Single-stream spatial multiplexing up to 72 Mbps.
- Supports 20 MHz channels with optional SGI.
- Full IEEE 802.11 b/g legacy compatibility with enhanced performance.
- TX and RX low-density parity check (LDPC) support for improved range and power efficiency.

- On-chip power and low-noise amplifiers.
- An internal fractional nPLL allows support for a wide range of reference clock frequencies.
- Integrated ARM Cortex-R4 processor with tightly coupled memory for complete WLAN subsystem functionality, minimizing the need to wake up the applications processor for standard WLAN functions (to further minimize power consumption while maintaining the ability to upgrade to future features in the field).
- Software architecture supported by standard WICED SDK allows easy migration from existing discrete MCU designs and to future devices.
- Security support:
 - WPA and WPA2 (Personal) support for powerful encryption and authentication.
 - AES and TKIP in hardware for faster data encryption and IEEE 802.11i compatibility.
 - Reference WLAN subsystem provides Cisco Compatible Extensions (CCX, CCX 2.0, CCX 3.0, CCX 4.0, and CCX 5.0).
 - Wi-Fi Protected Setup and Wi-Fi Easy-Setup
- Worldwide regulatory support: Global products supported with worldwide design approval.

Cypress Semiconductor Corporation
Document Number: 002-14826 Rev. *G

198 Champion Court

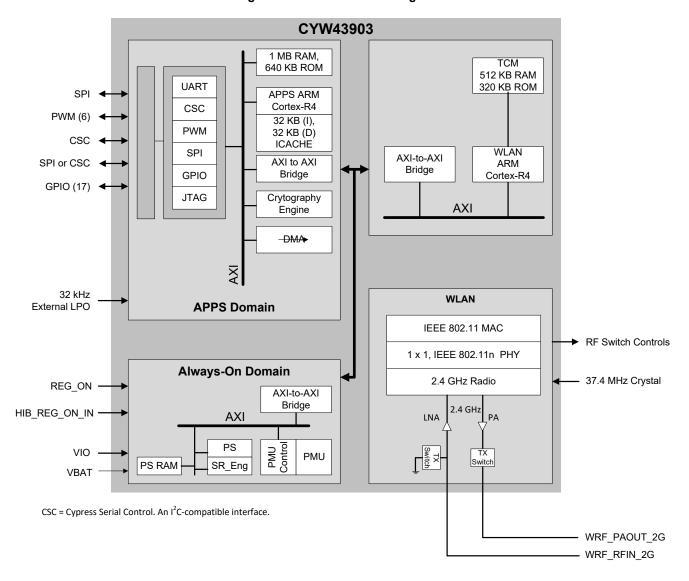
San Jose, CA 95134-1709 • 408-943-2600



General Features

- Supports battery voltage range from 3.0V to 4.8V with an internal switching regulator.
- Programmable dynamic power management.
- 6 Kb OTP memory for storing board parameters.
- 151-ball WLBGA (4.91mm x 5.85mm, 0.4 mm pitch).

Figure 1. Functional Block Diagram





Contents

1.	Ove	erview	. 5
	1.1	Introduction	
	1.2	Standards Compliance	7
2.	Pov	ver Supplies and Power Management	. 8
	2.1	Power Supply Topology	8
	2.2	CYW43903 Power Management Unit Features	8
	2.3	Power Management	
	2.4	PMU Sequencing	
	2.5	Power-Off Shutdown	
	2.6	Power-Up/Power-Down/Reset Circuits	
3.		quency References	
	3.1	Crystal Interface and Clock Generation	
	3.2	External Frequency Reference	
	3.3	External 32.768 kHz Low-Power Oscillator	
4.		olications Subsystem	
	4.1 4.2	Overview	
	4.2	Applications CPU and Memory Subsystem Memory-to-Memory DMA Core	
	4.4	Cryptography Core	
5		Dications Subsystem External Interfaces	
J.	5.1	GPIO	
	5.2	Cypress Serial Control	
	5.3	JTAG and ARM Serial Wire Debug	
	5.4	PWM	18
	5.5	SPI Flash	18
	5.6	UART	
	5.7	SPI	19
6.	Glo	bal Functions	20
	6.1	External Coexistence Interface	
		One-Time Programmable Memory	
	6.3	Hibernation Block	
	6.4	System Boot Sequence	
7.		eless LAN Subsystem	
	7.1	WLAN CPU and Memory Subsystem	
	7.2	7.2.1 PSM	
		7.2.2 WEP	
		7.2.3 TXE	
		7.2.4 RXE	
		7.2.6 TSF	24
		7.2.7 NAV	24

		7.2.8 MAC-PHY Interface	24
	7.3	IEEE 802.11 [™] b/g/n PHY	25
8.	WL	AN Radio Subsystem	26
	8.1	Receiver Path	26
	8.2	Transmit Path	26
	8.3	Calibration	26
9.	Pind	out and Signal Descriptions	27
	9.1	Ball Map	27
	9.2	Ball List	28
	9.3	Signal Descriptions	30
10	.GPI	O Signals and Strapping Options	34
	10.1	Overview	34
	10.2	Weak Pull-Down and Pull-Up Resistances	34
	10.3	Strapping Options	34
	10.4	Alternate GPIO Signal Functions	35
11	.Pin	Multiplexing	36
12	.1/0	States	38
13	.Elec	ctrical Characteristics	40
	13.1	Absolute Maximum Ratings	40
	13.2	Environmental Ratings	41
	13.3	Electrostatic Discharge Specifications	41
	13.4	Recommended Operating Conditions and DC Characteristics	41
	13.5	Power Supply Segments	43
	13.6	GPIO, UART, and JTAG Interfaces DC Characteristics	43
14	.WL	AN RF Specifications	44
	14.1	Introduction	44
	14.2	2.4 GHz Band General RF Specifications	44
	14.3	WLAN 2.4 GHz Receiver Performance Specifications	45
	14.4	WLAN 2.4 GHz Transmitter Performance Specifications	47
	14.5	General Spurious Emissions Specifications 14.5.1 Transmitter Spurious Emissions	
		Specifications	
4-	11	Specifications	
15		rnal Regulator Electrical Specifications.	
		Core Buck Switching Regulator	
		3.3V LDO (LDO3P3)	
	15.3	LNI DO	51



•	15.5	BBPLL LDO	53
16.	Sys	tem Power Consumption	54
	16.1	WLAN Current Consumption	
17.	SPI	Flash Characteristics	55
	17.1	SPI Flash Timing	55
		17.1.1 Read-Register Timing	
		17.1.2 Write-Register Timing	
		17.1.3 Memory Fast-Read Timing	
		17.1.4 Memory-Write Timing	
		17.1.5 SPI Flash Parameters	59
18.	Pow	ver-Up Sequence and Timing	60
	18.1	Sequencing of Reset and Regulator Control	
		Signals	60
		18.1.1 Description of Control Signals	
		18.1.2 Control Signal Timing Diagrams	

19. I nermai information	61
19.1 Package Thermal Characteristics	61
19.2 Junction Temperature Estimation and PSI _{JT} Versus THETA _{JC}	61
19.3 Environmental Characteristics	
20. Mechanical Information	62
21.Ordering Information	63
22. Additional Information	63
22.1 Acronyms and Abbreviations	63
22.2 IoT Resources	63
22.3 Errata	63
Document History Page	64
Sales, Solutions, and Legal Information	65



1. Overview

1.1 Introduction

The Cypress CYW43903 is a single-chip device that provides the highest level of integration for an embedded system-on-a-chip with integrated IEEE 802.11 b/g/n MAC/baseband/radio and a separate ARM Cortex-R4 applications processor. It provides a small form-factor solution with minimal external components to drive down cost for mass volumes and allows for an embedded system with flexibility in size, form, and function. Comprehensive power management circuitry and software ensure that the system can meet the needs of highly embedded systems that require minimal power consumption and reliable operation.

Figure 2 shows the interconnect of all the major physical blocks in the CYW43903 and their associated external interfaces, which are described in greater detail in Applications Subsystem External Interfaces.

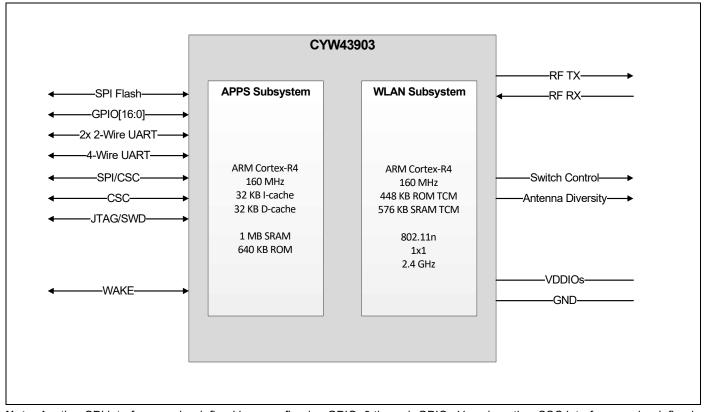


Figure 2. Block Diagram and I/O

Note: Another SPI interface can be defined by reconfiguring GPIO_8 through GPIO_11 and another CSC interface can be defined by reconfiguring GPIO_12 and GPIO_13 (see Table 11, "Pin Multiplexing,").



1.1.1 Features

The CYW43903 supports the following features:

- ARM Cortex-R4 clocked at 160 MHz.
- 1 MB of SRAM and 640 KB ROM available for the applications processor.
- One high-speed 4-wire UART interface with operation up to 4 Mbps.
- Two low-speed 2-wire UART interfaces multiplexed on general purpose I/O (GPIO) pins.
- One dedicated CSC¹ interface.

Note: Another CSC interface can be defined by reconfiguring GPIOs. See Table 11, "Pin Multiplexing,".

■ One SPI master interface with operation up to 24 MHz.

Either or both of the SPI interfaces can be used as CSC master interfaces. This is in addition to the two dedicated CSC interfaces.

Note: In addition to the dedicated CSC interface, the SPI interface can be used as a CSC master interface.

Note: Another SPI interface can be defined by reconfiguring GPIOs. See Table 11, "Pin Multiplexing,".

- One SPI master interface for serial flash.
- Six dedicated PWM outputs.
- 17 GPIOs.
- IEEE 802.11 b/g/n 1×1 2.4 GHz radio.
- Single- and dual-antenna support.

Document Number: 002-14826 Rev. *G Page 6 of 65

^{1.}Cypress Serial Control (CSC) is an I²C-compatible interface.



1.2 Standards Compliance

The CYW43903 supports the following standards:

- IEEE 802.11n
- IEEE 802.11b
- IEEE 802.11g
- IEEE 802.11d
- IEEE 802.11h
- IEEE 802.11i
- Security:
 - □ WEP
 - □ WPA Personal
 - □ WPA2 Personal
 - □ WMM
 - □ WMM-PS (U-APSD)
 - □ WMM-SA
 - □ AES (hardware accelerator)
 - □ TKIP (hardware accelerator)
 - □ CKIP (software support)
- Proprietary Protocols:
 - □ CCXv2
 - □ CCXv3
 - □ CCXv4
 - □ CCXv5
 - □ WFAEC

The CYW43903 supports the following additional standards:

- IEEE 802.11r—Fast Roaming (between APs)
- IEEE 802.11w—Secure Management Frames
- IEEE 802.11 Extensions:
- IEEE 802.11e QoS enhancements (already supported as per the WMM specification)
- IEEE 802.11i MAC enhancements
- IEEE 802.11k radio resource measurement



2. Power Supplies and Power Management

2.1 Power Supply Topology

One core buck regulator, multiple LDO regulators, and a power management unit (PMU) are integrated into the CYW43903. All regulators are programmable via the PMU. These blocks simplify power supply design for application and WLAN functions in embedded designs.

A single VBAT (3.0V to 4.8V DC maximum) and VIO supply (1.8V to 3.3V) can be used, with all additional voltages being provided by the regulators in the CYW43903.

The REG_ON control signal is used to power up the regulators and take the appropriate sections out of reset. The CBUCK, CLDO, LNLDO, and other regulators power up when any of the reset signals are deasserted. All regulators are powered down only when REG_ON is deasserted. The regulators may be turned off/on based on the dynamic demands of the digital baseband.

The CYW43903 provides a low power-consumption mode whereby the CBUCK, CLDO, and LNLDO regulators are shut down. When in this state, the low-power linear regulator (LPLDO1) supplied by the system VIO supply provides the CYW43903 with all required voltages.

2.2 CYW43903 Power Management Unit Features

The CYW43903 supports the following Power Management Unit (PMU) features:

- VBAT to 1.35Vout (550 mA maximum) core buck (CBUCK) switching regulator
- VBAT to 3.3Vout (450 mA maximum) LDO3P3
- 1.35V to 1.2Vout (350 mA maximum) CLDO with bypass mode for deep-sleep
- 1.35V to 1.2Vout (55 mA maximum) LDO for BBPLL
- Additional internal LDOs (not externally accessible)
- PMU internal timer auto-calibration by the crystal clock for precise wake-up timing from the low power-consumption mode.

Figure 3 and Figure 4 show the regulators and a typical power topology.

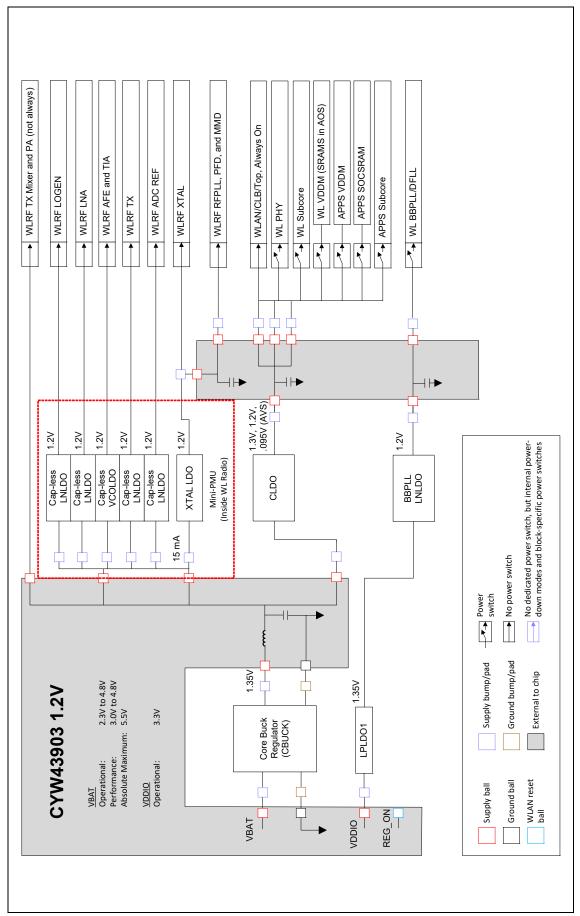
Document Number: 002-14826 Rev. *G Page 8 of 65

PRELIMINARY

CYW43903



Figure 3. Typical Power Topology (Page 1 of 2)



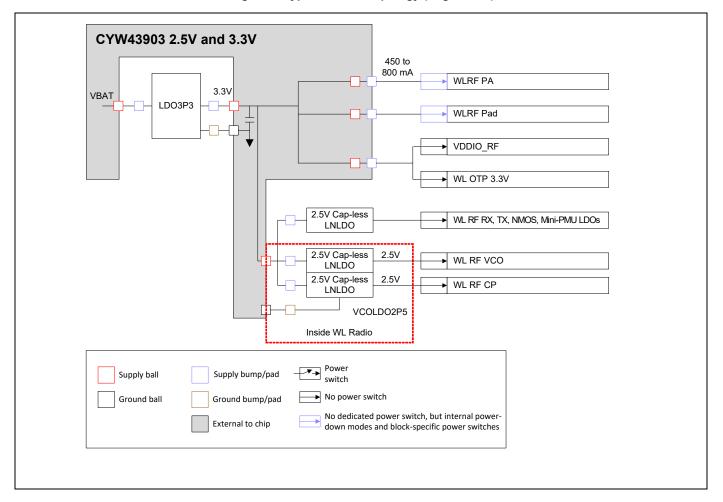


Figure 4. Typical Power Topology (Page 2 of 2)



2.3 Power Management

The CYW43903 has been designed with the stringent power consumption requirements of mobile devices in mind. All areas of the chip design are optimized to minimize power consumption. Silicon processes and cell libraries were chosen to reduce leakage current and supply voltages. Additionally, the CYW43903 includes an advanced Power Management Unit (PMU) sequencer. The PMU sequencer provides significant power savings by putting the CYW43903 into various power management states appropriate to the environment and activities that are being performed. The power management unit enables and disables internal regulators, switches, and other blocks based on a computation of the required resources and a table that describes the relationship between resources and the time needed to enable and disable them. Power-up sequences are fully programmable. Configurable, free-running counters (running at a 32.768 kHz LPO clock) in the PMU sequencer are used to turn on and turn off individual regulators and power switches. Clock speeds are dynamically changed (or gated altogether) as a function of the mode. Slower clock speeds are used whenever possible.

Table 2 provides descriptions for the CYW43903 power modes.

Table 2. CYW43903 Power Modes

Mode	Description
Active	All WLAN blocks in the CYW43903 are powered up and fully functional with active carrier sensing and frame transmission and receiving.
	All required regulators are enabled and put in the most efficient mode based on the load current. Clock speeds are dynamically adjusted by the PMU sequencer.
Doze	The radio, analog domains, and most of the linear regulators are powered down. The rest of the CYW43903 remains powered up in an idle state. All main clocks (PLL, crystal oscillator, or TCXO) are shut down to minimize active power consumption. The 32.768 kHz LPO clock is available only for the PMU sequencer. This condition is necessary to allow the PMU sequencer to wake up the chip and transition to Active mode. In Doze mode, the primary power consumed is due to leakage current.
Deep-sleep	Most of the chip, including both analog and digital domains and most of the regulators, is powered off. Logic states in the digital core are saved and preserved in a retention memory in the Always-On domain before the digital core is powered off. Upon a wake-up event triggered by the PMU timers or an external interrupt, logic states in the digital core are restored to their pre-deep-sleep settings to avoid lengthy HW reinitialization.
Power-down	The CYW43903 is effectively powered off by shutting down all internal regulators. The chip is brought out of this mode by external logic re-enabling the internal regulators.

2.4 PMU Sequencing

The PMU sequencer minimizes system power consumption. It enables and disables various system resources based on a computation of required resources and a table that describes the relationship between resources and the time required to enable and disable them.

Resource requests can come from several sources: clock requests from cores, the minimum resources defined in the *ResourceMin* register, and the resources requested by any active resource-request timers. The PMU sequencer maps clock requests into a set of resources required to produce the requested clocks.

Each resource is in one of the following four states:

- enabled
- disabled
- transition_on
- transition_off

The timer contains 0 when the resource is enabled or disabled and a nonzero value when in a transition state. The timer is loaded with the time_on or time_off value of the resource after the PMU determines that the resource must be enabled or disabled and decrements on each 32.768 kHz PMU clock. When it reaches 0, the state changes from transition_off to disabled or transition_on to enabled. If the time_on value is 0, the resource can transition immediately from disabled to enabled. Similarly, a time_off value of 0 indicates that the resource can transition immediately from enabled to disabled. The terms *enable sequence* and *disable sequence* refer to either the immediate transition or the timer load-decrement sequence.

Document Number: 002-14826 Rev. *G Page 11 of 65



During each clock cycle, the PMU sequencer performs the following actions:

- Computes the required resource set based on requests and the resource dependency table.
- Decrements all timers whose values are nonzero. If a timer reaches 0, the PMU clears the ResourcePending bit of the resource and inverts the ResourceState bit.
- Compares the request with the current resource status and determines which resources must be enabled or disabled.
- Initiates a disable sequence for each resource that is enabled, is no longer being requested, and has no powered-up dependents.
- Initiates an enable sequence for each resource that is disabled, is being requested, and has all of its dependencies enabled.

2.5 Power-Off Shutdown

The CYW43903 provides a low-power shutdown feature that allows the device to be turned off while the host, and any other system devices remain operational. When the CYW43903 is not needed in the system, VDDIO_RF and VDDC are shut down while VDDIO remains powered. This allows the CYW43903 to be effectively off while keeping the I/O pins powered so that they do not draw extra current from devices connected to the I/O.

During a low-power shutdown state, provided VDDIO remains applied to the CYW43903, all outputs are tristated and most inputs signals are disabled. Input voltages must remain within the limits defined for normal operation. This is done to prevent current paths or create loading on any digital signals in the system, and enables the CYW43903 to be fully integrated in an embedded device while taking full advantage of the lowest power-saving modes.

When the CYW43903 is powered on from this state, it is the same as a normal power-up and does not retain any information about its state from before it was powered down.

2.6 Power-Up/Power-Down/Reset Circuits

The CYW43903 has two signals (see Table 3) that enable or disable circuits and the internal regulator blocks, allowing the host to control power consumption. For timing diagrams of these signals and the required power-up sequences, see Power-Up Sequence and Timing.

Table 3. Power-Up/Power-Down/Reset Control Signals

Signal	Description
REG_ON	This signal is used by the PMU to power up the CYW43903. It controls the internal CYW43903 regulators. When this pin is high, the regulators are enabled and the device is out of reset. When this pin is low, the device is in reset and the regulators are disabled. This pin has an internal 200 k Ω pull-down resistor that is enabled by default. It can be disabled through programming.
HIB_REG_ON_IN	This signal is used by the hibernation block to decide whether or not to power down the internal CYW43903 regulators. If HIB_REG_ON_IN is low, the regulators will be disabled. For a signal at HIB_REG_ON_IN to function as intended, HIB_REG_ON_OUT must be connected to REG_ON.

Document Number: 002-14826 Rev. *G Page 12 of 65



3. Frequency References

An external crystal is used for generating all radio frequencies and normal-operation clocking. As an alternative, an external frequency reference can be used. In addition, a low-power oscillator (LPO) is provided for lower power mode timing.

3.1 Crystal Interface and Clock Generation

The CYW43903 can use an external crystal to provide a frequency reference. The recommended crystal oscillator configuration, including all external components, is shown in Figure 5. Consult the reference schematics for the latest configuration.

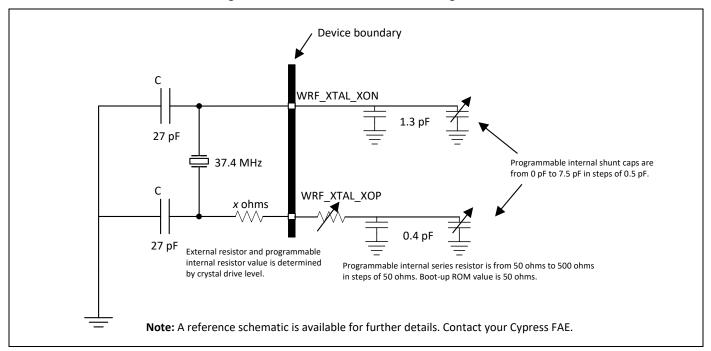


Figure 5. Recommended Oscillator Configuration

A fractional-N synthesizer in the CYW43903 generates the radio frequencies, clocks, and data/packet timing, enabling it to operate using a wide selection of frequency references.

The recommended default frequency reference is a 37.4 MHz crystal. The signal characteristics for the crystal interface are listed in Table 4.

Note: Although the fractional-N synthesizer can support alternative reference frequencies, frequencies other than the default require support to be added in the driver, plus additional extensive system testing. Contact Cypress for further details.



3.2 External Frequency Reference

As an alternative to a crystal, an external precision frequency reference can be used, provided that it meets the phase noise requirements listed in Table 4.

If used, the external clock should be connected to the WRF_XTAL_XON pin through an external 1000 pF coupling capacitor, as shown in Figure 6. The internal clock buffer connected to this pin will be turned off when the CYW43903 goes into sleep mode. When the clock buffer turns on and off, there will be a small impedance variation. Power must be supplied to the WRF_XTAL_VDD1P35 pin.

Figure 6. Recommended Circuit to Use With an External Reference Clock

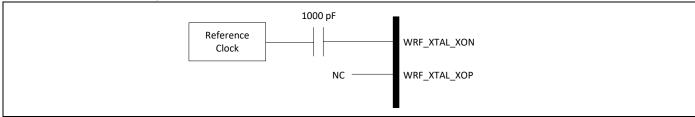


Table 4. Crystal Oscillator and External Clock—Requirements and Performance

			Crystal ¹	l	Exteri R			
Parameter	Conditions/Notes	Min.	Тур.	Max.	Min.	Тур.	Max.	Units
Frequency	2.4 GHz and 5 GHz bands: IEEE 802.11a/b/g/n operation	-	37.4	_	_	-37.4	_	MHz
Frequency tolerance over the lifetime of the equipment, including temperature ³	Without trimming	-20	-	20	-20	-	20	ppm
Crystal load capacitance	_	_	16	-	_	_	_	pF
ESR	-	_	_	60	_	_	_	Ω
Drive level	External crystal must be able to tolerate this drive level.	200	_	_	-	_	-	μW
Input impedance	Resistive	_	_	-	30k	100k	_	Ω
(WRF_XTAL_XON)	Capacitive	_	_	7.5	_	_	7.5	pF
WRF_XTAL_XON Input low level	DC-coupled digital signal	_	_	_	0	_	0.2	V
WRF_XTAL_XON Input high level	DC-coupled digital signal	_	_	_	1.0	_	1.26	V
WRF_XTAL_XON input voltage (see Figure 6)	IEEE 802.11b/g operation only	-	_	_	400	_	1200	mV _{p-p}
WRF_XTAL_XON input voltage (see Figure 6)	IEEE 802.11n AC-coupled analog input	-	_	_	1	_	_	V _{p-p}
Duty cycle	37.4 MHz clock	_	_	-	40	50	60	%
Phase noise ⁴	37.4 MHz clock at 10 kHz offset	_	_	_	-	_	-129	dBc/Hz
(IEEE 802.11b/g) 37.4 MHz clock at 100 kHz offset			_		_	_	-136	dBc/Hz
Phase noise ⁴	37.4 MHz clock at 10 kHz offset	-	_	_	_	_	-134	dBc/Hz
(IEEE 802.11n, 2.4 GHz)	37.4 MHz clock at 100 kHz offset	_	_	_	_	_	-141	dBc/Hz

^{1. (}Crystal) Use WRF_XTAL_XON and WRF_XTAL_XOP.

^{2.} See External Frequency Reference for alternative connection methods.

^{3.} It is the responsibility of the equipment designer to select oscillator components that comply with these specifications.

^{4.} Assumes that external clock has a flat phase noise response above 100 kHz.



3.3 External 32.768 kHz Low-Power Oscillator

The CYW43903 uses a secondary low frequency clock for low-power-mode timing. Either the internal low-precision LPO or an external 32.768 kHz precision oscillator is required. The internal LPO frequency range is approximately 33 kHz ± 30% over process, voltage, and temperature, which is adequate for some applications. However, one tradeoff caused by this wide LPO tolerance is a small current consumption increase during power save mode that is incurred by the need to wake-up earlier to avoid missing beacons.

Whenever possible, the preferred approach is to use a precision external 32.768 kHz clock that meets the requirements listed in Table 5.

Table 5. External 32.768 kHz Sleep Clock Specifications

Parameter	LPO Clock	Units
Nominal input frequency	32.768	kHz
Frequency accuracy	±200	ppm
Duty cycle	30-70	%
Input signal amplitude	200–3300	mV, p-p
Signal type	Square-wave or sine-wave	_
Input impedance ¹	>100k	Ω
	<5	pF
Clock jitter (during initial start-up)	<10,000	ppm

^{1.} When power is applied or switched off.

Document Number: 002-14826 Rev. *G Page 15 of 65



4. Applications Subsystem

4.1 Overview

The Applications subsystem contains the general use CPU, memory, the standalone DMA core, the cryptography core, and the majority of the external interfaces.

4.2 Applications CPU and Memory Subsystem

This subsystem has an integrated 32-bit ARM Cortex-R4 processor with an internal 32 KB D-cache and an internal 32 KB I-cache. The ARM Cortex-R4 is a low-power processor that features a low gate count, low interrupt latency, and low-cost debugging capabilities. It is intended for deeply embedded applications that require fast interrupt response features. The ARM Cortex-R4 implements the ARM v7-R architecture and supports the Thumb-2 instruction set.

At 0.19 μ W/MHz, the Cortex-R4 is the most power efficient general-purpose microprocessor available, outperforming 8- and 16-bit devices on a MIPS/ μ W basis. It also supports integrated sleep modes.

Using multiple technologies to reduce cost, the ARM Cortex-R4 enables improved memory utilization, reduced pin overhead, and reduced silicon area. It also has extensive debugging features, including real-time tracing of program execution.

On-chip memory for the CPU includes 1 MB SRAM, 640 KB ROM, and an 8 KB RAM powered independently of the application subsystem.

4.3 Memory-to-Memory DMA Core

The CYW43903 memory-to-memory DMA (M2MDMA) engine contains eight DMA channel pairs, each containing one transmit/pull engine and one receive/push engine.

The DMA engine provides general purpose data movement between memories that can be on the device, attached directly to the device, or accessed through a host interface. The transmit/pull engine reads data from the source memory and immediately passes it to the paired receive/push engine, which proceeds to write it to the destination memory. Multiple masters can program the individual channels, and multiple interrupts are provided so that interrupts for different channels can be routed separately to different masters.

4.4 Cryptography Core

This core provides general purpose data movement between memories, which may be either on the device, attached directly to the device, or accessed through a host interface. The transmit/pull engine reads data from the source memory and passes it immediately to the paired receive/push engine that proceeds to write it to the destination memory. Multiple masters may program the individual channels, and multiple interrupts are provided so that interrupts for different channels can be routed separately to different masters.

The cryptography block provides a hardware accelerator for enciphering and deciphering data that has undergone processing using standards-based encryption algorithms. The cryptography block includes the following primary features:

- Encryption and hash engines that support single pass AUTH-ENC or ENC-AUTH processing.
- A scalable AES module that supports CBC, ECB, CTR, CFB, OFB, and XTS encryption with 128-, 192-, and 256-bit key sizes.
- A scalable DES module that supports DES and 3DES in ECB and CBC modes.
- An RC4 stream cipher module that supports state initialization, state update, and key-stream generation.
- MD5, SHA1, SHA224, and SHA256 engines that support pure hash or HMAC operations.
- A built-in 512-byte key cache for locally protected key storage.

OTP memory is used to store authentication keys.

Document Number: 002-14826 Rev. *G Page 16 of 65



5. Applications Subsystem External Interfaces

5.1 GPIO

There are 17 general-purpose I/O (GPIO) pins available on the CYW43903. The GPIOs can be used to connect to various external devices.

Upon power-up and reset, these pins are tristated. Subsequently, they can be programmed to be either input or output pins via the GPIO control register. In addition, the GPIO pins can be assigned to various other functions.

Apart from other functions, GPIOs are used to set bootstrap options and use the JTAG interface for debugging during software development.

5.2 Cypress Serial Control

The CYW43903 has two Cypress Serial Control (CSC²) master interfaces for external communication with codecs, DACs, NVRAM, etc. The I/O pads can be configured as pull-ups or pull-ups can be installed on the reference design to support a multimaster on an open drain bus.

5.3 JTAG and ARM Serial Wire Debug

The CYW43903 supports the IEEE 1149.1 JTAG boundary scan standard for performing device package and PCB assembly testing during manufacturing. In addition, the JTAG interface allows Cypress to assist customers by using proprietary debug and characterization test tools during board bring-up. Therefore, it is highly recommended to provide access to the JTAG pins by means of test points or a header on all PCB designs.

The CYW43903 also supports ARM Serial Wire Debug (SWD) for connecting a JTAG debugger directly to both ARM Cortex-R4s. For SWD, the combination of a clock and a bidirectional signal (on a single pin) provides normal JTAG debug and test functionality. The reduced pin-count SWD interface is a high-performance alternative to the JTAG interface.

Table 6 shows the JTAG_SEL and TAP_SEL states for test and debug function selection. Test and debug function selection is independent of the debugging interface (JTAG or SWD) being used.

Table 6. JTAG_SEL and TAP_SEL States for Test and Debug Function Selection

JTAG_SEL State	TAP_SEL State	Test and Debug Function
0	0	JTAG not used.
0	1	JTAG not used.
1	0	Access the LV tap directly for ATE and bring-up.
1	1	Access either of the ARM Cortex-R4's directly via either the 5-pin JTAG port or the 2-pin SWD configuration.

Note: JTAG_SEL is exposed on a dedicated physical pin. TAP_SEL uses the GPIO_8 physical pin.

Document Number: 002-14826 Rev. *G Page 17 of 65

^{2.} Cypress Serial Control is an I²C compatible interface.



5.4 PWM

The CYW43903 provides up to six independent pulse width modulation (PWM) channels. The following features apply to the PWM channels:

- Each channel is a square wave generator with a programmable duty cycle.
- Each channel generates its duty cycle by dividing down the input clock.
- Both the high and low duration of the duty cycle can be divided down independently by a 16-bit divider register.
- Each channel can work independently or update simultaneously.
- Pairs of PWM outputs can be inverted for devices that need a differential output.
- Continuous or single pulses can be generated.
- The input clock can either be a high-speed clock from a PLL channel or a lower speed clock at the crystal frequency.

5.5 SPI Flash

The SPI flash interface supports the following features:

- A SPI-compatible serial bus.
- An 80 MHz (maximum) clock frequency.
- Increased Throughput to 40 MBps in Quad-mode or upto 10 MBps in single Mode³.
- Support for either ×1 or ×4 addresses with ×4 data.
- 3-bytes and 4-byte addressing modes.
- A configurable dummy-cycle count that is programmable from 1 to 15.
- Programmable instructions output to serial flash.
- An option to change the sampling edge from rising-edge to falling-edge for read-back data when in high-speed mode.

5.6 UART

A high-speed 4-wire CTS/RTS UART interface can be enabled by software and has dedicated pins. Provided primarily for debugging during development, this UART enables the CYW43903 to operate as RS-232 data termination equipment (DTE) for exchanging and managing data with other serial devices. It is compatible with the industry standard 16550 UART and provides a FIFO size of 64 × 8 in each direction.

There are two low-speed UART interfaces on the CYW43903. Each functions as a standard 2-wire UART. They are also enabled as alternate functions on GPIOs and can be enabled independently of the 4-wire fast UART.

Note: The high-speed, 4-wire UART interface is identified as UART0 in this document and in reference schematics. The two low-speed, 2-wire UART interfaces are identified as UART1 and UART2 in this document and in the reference schematics.

Document Number: 002-14826 Rev. *G Page 18 of 65

^{3.} Note that the clock needs to be constrained to ~26.67MHz for reliable operation at high operating temperatures. The throughput of the SPI Flash block is therefore restricted to ~13 MBps for Quad mode and ~3 MBps for single mode.



5.7 SPI

CYW43903 contains one SPI block. This block support a fixed SPI mode (CPOL = 0, CPHA = 0) and 8-bit data read/write.

- CPOL = 0: Clock idles at 0, and each cycle consists of a pulse of 1. The leading edge is a rising edge, and the trailing edge is a falling edge.
- CPHA = 0: The "out" side changes the data on the trailing edge of the preceding clock cycle, while the "in" side captures the data on (or shortly after) the leading edge of the clock cycle.

The SPI hardware block supports a hold time of 25ns and a maximum clock frequency of 40MHz. If a SPI slave does not support the above mode or requires a hold time greater than 25ns, a bit banging software SPI driver should be used. Cypress's WICED SDK provides and example of such a driver.

Note that the maximum SPI frequency support by a software SPI driver is much lower than 40 MHz.

SPI0 mentioned in Table 8 is multiplexed with GPIOs and can therefore support a bit banging based software SPI driver.

Document Number: 002-14826 Rev. *G Page 19 of 65



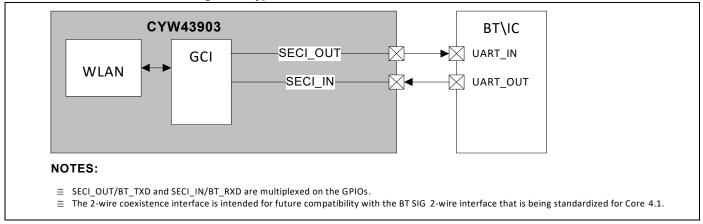
6. Global Functions

6.1 External Coexistence Interface

An external handshake interface is available to enable signaling between the device and an external colocated wireless device, such as Bluetooth, to manage wireless medium sharing for optimum performance.

Figure 7 shows the coexistence interface.

Figure 7. Cypress 2-Wire External Coexistence Interface



Note: SECI UART is the same as UART2, one of the low-speed UART interfaces mentioned in section 5.7 and in the reference schematics.

6.2 One-Time Programmable Memory

Various hardware configuration parameters can be stored in an internal 6144-bit (768 bytes) One-Time Programmable (OTP) memory that is read by system software after a device reset. In addition, customer-specific parameters, including the system vendor ID and MAC address can be stored, depending on the specific board design.

The initial state of all bits in an unprogrammed OTP memory device is 0. After any bit is programmed to a 1, it cannot be reprogrammed to 0. The entire OTP memory array can be programmed in a single write-cycle using a utility provided with the Cypress WLAN manufacturing test tools. Alternatively, multiple write cycles can be used to selectively program specific bytes, but only bits that are still in the 0 state can be altered during each programming cycle.

Prior to OTP memory programming, all values should be verified using the appropriate editable nvram.txt file. The nvram.txt file is provided with the reference board design package.

6.3 Hibernation Block

The Hibernation (HIB) block is a self-contained power domain that can be used to completely shut down the rest of the CYW43903. This optional block uses the HIB_REG_ON_OUT pin to drive the REG_ON pin. Therefore, for the HIB block to work as designed, the HIB_REG_ON_OUT pin must be connected to the REG_ON pin. To use the HIB block, software programs the HIB block with a wake count and then asserts a signal indicating that the chip should be put into hibernation. After assertion, the HIB block drives HIB_REG_ON_OUT low for the number of 32 kHz clock cycles programmed as the wake count. After the wake-count timer expires, HIB_REG_ON_OUT is driven high. Other than the logic state of the HIB block, no state is saved in the CYW43903 during hibernation.

Document Number: 002-14826 Rev. *G Page 20 of 65



6.4 System Boot Sequence

The following general sequence occurs after a CYW43903 is powered on:

1. Either REG_ON or HIB_REG_ON_IN is asserted.

Note: For HIB_REG_ON_IN to function as intended, HIB_REG_ON_OUT must be connected to REG_ON.

- 2. The core LDO (CLDO) and LDO3P3 outputs stabilize.
- 3. The OTP memory bits are used to initialize various functions, such as PMU trimming, package selection, memory size selection, etc.
- 4. The APP and WLAN cores are powered up.
- 5. The XTAL is powered up.
- 6. The APP and WLAN CPU bootup sequences start.

Document Number: 002-14826 Rev. *G Page 21 of 65



7. Wireless LAN Subsystem

7.1 WLAN CPU and Memory Subsystem

The CYW43903 WLAN section includes an integrated 32-bit ARM Cortex-R4 processor with internal RAM and ROM. The ARM Cortex-R4 is a low-power processor that features a low gate count, a small interrupt latency, and low-cost debug capabilities. It is intended for deeply embedded applications that require fast interrupt response features. Delivering more than a 30% performance gain over ARM7TDMI, the ARM Cortex-R4 implements the ARM v7-R architecture with support for the Thumb-2 instruction set.

At 0.19 μ W/MHz, the Cortex-R4 is the most power efficient general-purpose microprocessor available, outperforming 8- and 16-bit devices on MIPS/ μ W. It also supports integrated sleep modes.

On-chip memory for this CPU includes 576 KB of SRAM and 448 KB of ROM.

7.2 IEEE 802.11n MAC

The CYW43903 WLAN media access controller (MAC) is designed to support high-throughput operation with low power consumption. It does so without compromising the Bluetooth coexistence policies, thereby enabling optimal performance over both networks. In addition, several power-saving modes have been implemented that allow the MAC to consume very little power while maintaining network-wide timing synchronization. The architecture diagram of the MAC is shown in Figure 8.

The following sections provide an overview of the important MAC modules.

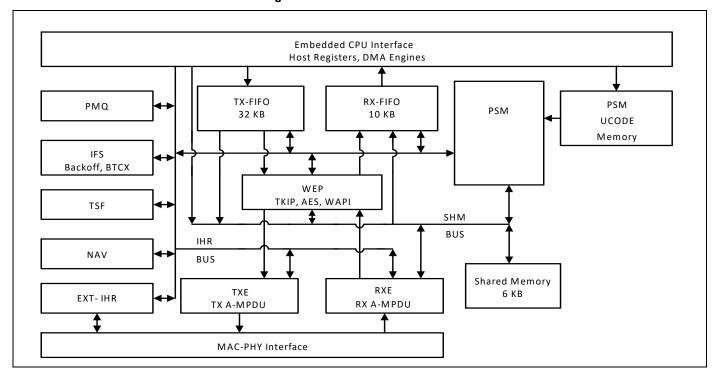


Figure 8. WLAN MAC Architecture

The CYW43903 WLAN MAC supports features specified in the IEEE 802.11 base standard and amended by IEEE 802.11n. The key MAC features include:

- Transmission and reception of aggregated MPDUs (A-MPDU) for high throughput (HT).
- Support for power management schemes, including WMM power-save, power-save multi-poll (PSMP), and multiphase PSMP operation.
- Support for immediate ACK and Block-ACK policies.
- Interframe space timing support, including RIFS.



- Support for RTS/CTS and CTS-to-self frame sequences for protecting frame exchanges.
- Back-off counters in hardware for supporting multiple priorities as specified in the WMM specification.
- Timing synchronization function (TSF), network allocation vector (NAV) maintenance, and target beacon transmission time (TBTT) generation in hardware.
- Hardware offload for AES-CCMP, legacy WPA TKIP, legacy WEP ciphers, WAPI, and support for key management.
- Support for coexistence with Bluetooth and other external radios.
- Programmable independent basic service set (IBSS) or infrastructure basic service set functionality.
- Statistics counters for MIB support.

7.2.1 PSM

The programmable state machine (PSM) is a microcoded engine that provides most of the low-level control to the hardware in order to implement the IEEE 802.11 specification. It is a microcontroller that is highly optimized for flow-control operations, which are predominant in implementations of communication protocols. The instruction set and fundamental operations are simple and general, allowing algorithms to be optimized very late in the design process. It also allows for changes to the algorithms to track evolving IEEE 802.11 specifications.

The PSM fetches instructions from microcode memory. It uses the shared memory to obtain operands for instructions, as a data store, and to exchange data between both the host and the MAC data pipeline (via the SHM bus). The PSM also uses a scratch-pad memory (similar to a register bank) to store frequently accessed and temporary variables.

The PSM exercises fine-grained control over the hardware engines by programming internal hardware registers (IHR). These IHRs are colocated with the hardware functions they control and are accessed by the PSM via the IHR bus.

The PSM fetches instructions from the microcode memory using an address determined by the program counter, instruction literal, or a program stack. For ALU operations, the operands are obtained from shared memory, scratch-pad memory, IHRs, or instruction literals, and the results are written into the shared memory, scratch-pad memory, or IHRs.

There are two basic branch instructions: conditional branches and ALU-based branches. To better support the many decision points in the IEEE 802.11 algorithms, branches can depend on either readily available signals from the hardware modules (branch condition signals are available to the PSM without polling the IHRs) or on the results of ALU operations.

7.2.2 WEP

The wired equivalent privacy (WEP) engine encapsulates all the hardware accelerators to perform encryption and decryption as well as MIC computation and verification. The accelerators implement the following cipher algorithms: legacy WEP, WPA TKIP, WPA2 AES-CCMP.

The PSM determines, based on the frame type and association information, the appropriate cipher algorithm to use. It supplies the keys to the hardware engines from an on-chip key table. The WEP interfaces with the transmit engine (TXE) to encrypt and compute the MIC on transmit frames and the receive engine (RXE) to decrypt and verify the MIC on receive frames.

7.2.3 TXE

The transmit engine (TXE) constitutes the transmit data path of the MAC. It coordinates the DMA engines to store the transmit frames in the TXFIFO. It interfaces with the WEP module to encrypt frames and transfers the frames across the MAC-PHY interface at the appropriate time determined by the channel-access mechanisms.

The data received from the DMA engines are stored in transmit FIFOs. The MAC has multiple logical queues to support traffic streams that have different QoS priority requirements. The PSM uses the channel access information from the IFS module to schedule a queue from which the next frame is transmitted. Once the frame is scheduled, the TXE hardware transmits the frame based on a precise timing trigger received from the IFS module.

The TXE module also contains the hardware that allows the rapid assembly of MPDUs into an A-MPDU for transmission. The hardware module aggregates the encrypted MPDUs by adding appropriate headers and pad delimiters as needed.

Document Number: 002-14826 Rev. *G Page 23 of 65



7.2.4 RXE

The receive engine (RXE) constitutes the receive data path of the MAC. It interfaces with the DMA engine to drain the received frames from the RXFIFO. It transfers bytes across the MAC-PHY interface and interfaces with the WEP module to decrypt frames. The decrypted data is stored in the RXFIFO.

The RXE module contains filters that are programmed by the PSM to accept or filter frames based on several criteria such as receiver address, BSSID, and certain frame types.

The RXE module also contains the hardware required to detect A-MPDUs, parse the headers of the containers, and disaggregate them into component MPDUS.

7.2.5 IFS

The IFS module contains the timers required to determine interframe-space timing including RIFS timing. It also contains multiple backoff engines required to support prioritized access to the medium as specified by WMM.

The interframe-spacing timers are triggered by the cessation of channel activity on the medium, as indicated by the PHY. These timers provide precise timing to the TXE to begin frame transmission. The TXE uses this information to send response frames or perform transmit frame-bursting (RIFS or SIFS separated, as within a TXOP).

The backoff engines (for each access category) monitor channel activity, in each slot duration, to determine whether to continue or pause the backoff counters. When the backoff counters reach 0, the TXE gets notified so that it may commence frame transmission. In the event of multiple backoff counters decrementing to 0 at the same time, the hardware resolves the conflict based on policies provided by the PSM.

The IFS module also incorporates hardware that allows the MAC to enter a low-power state when operating under the IEEE power save mode. In this mode, the MAC is in a suspended state with its clock turned off. A sleep timer, whose count value is initialized by the PSM, runs on a slow clock and determines the duration over which the MAC remains in this suspended state. When the timer expires, the MAC is restored to its functional state. The PSM updates the TSF timer based on the sleep duration, ensuring that the TSF is synchronized to the network.

The IFS module also contains the PTA hardware that assists the PSM in Bluetooth coexistence functions.

7.2.6 TSF

The timing synchronization function (TSF) module maintains the TSF timer of the MAC. It also maintains the target beacon transmission time (TBTT). The TSF timer hardware, under the control of the PSM, is capable of adopting timestamps received from beacon and probe response frames in order to maintain synchronization with the network.

The TSF module also generates trigger signals for events that are specified as offsets from the TSF timer, such as uplink and downlink transmission times used in PSMP.

7.2.7 NAV

The network allocation vector (NAV) timer module is responsible for maintaining the NAV information conveyed through the duration field of MAC frames. This ensures that the MAC complies with the protection mechanisms specified in the standard.

The hardware, under the control of the PSM, maintains the NAV timer and updates the timer appropriately based on received frames. This timing information is provided to the IFS module, which uses it as a virtual carrier-sense indication.

7.2.8 MAC-PHY Interface

The MAC-PHY interface consists of a data path interface to exchange RX/TX data from/to the PHY. In addition, there is an programming interface that can be controlled either by the host or the PSM to configure and control the PHY.

Document Number: 002-14826 Rev. *G Page 24 of 65



7.3 IEEE 802.11[™] b/g/n PHY

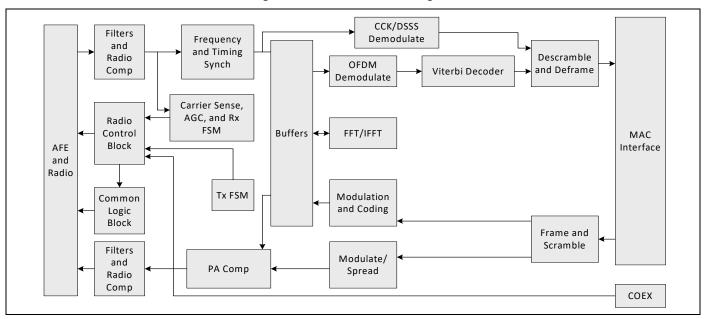
The CYW43903 WLAN digital PHY complies with IEEE 802.11b/g/n single-stream specifications to provide wireless LAN connectivity supporting data rates from 1 Mbps to 72 Mbps for low-power, high-performance, handheld applications.

The PHY has been designed to work in the presence of interference, radio nonlinearity, and various other impairments. It incorporates optimized implementations of filters, FFTs, and Viterbi-decoder algorithms. Efficient algorithms have been designed to achieve maximum throughput and reliability, including algorithms for carrier sensing and rejection, frequency/phase/timing acquisition and tracking, and channel estimation and tracking. The PHY receiver also contains a robust IEEE 802.11b demodulator. The PHY carrier-sensing algorithm provides high throughput for IEEE 802.11b/g hybrid networks with Bluetooth coexistence.

The key PHY features include:

- Programmable data rates from MCS0-7 in 20 MHz channels.
- Support for Optional Short GI and Green Field modes in TX and RX.
- TX and RX LDPC for improved range and power efficiency.
- All scrambling, encoding, forward error correction, and modulation in the transmit direction and inverse operations in the receive direction.
- Support for IEEE 802.11h/k for worldwide operation.
- Advanced algorithms for low power consumption and enhanced sensitivity, range, and reliability.
- Algorithms to improve performance in the presence of externally received Bluetooth signals.
- An automatic gain control scheme for blocking and nonblocking cellular applications.
- Closed loop transmit power control.
- Digital RF chip calibration algorithms to handle CMOS RF chip process, voltage, and temperature (PVT) variations.
- On-the-fly channel frequency and transmit power selection.
- Per-packet RX antenna diversity.
- Available per-packet channel quality and signal-strength measurements.
- Compliance with FCC and other worldwide regulatory requirements.

Figure 9. WLAN PHY Block Diagram





8. WLAN Radio Subsystem

The CYW43903 includes an integrated WLAN RF transceiver that has been optimized for use in 2.4 GHz Wireless LAN systems. It has been designed to provide low-power, low-cost, and robust communications for applications operating in the globally available 2.4 GHz unlicensed ISM band. The transmit and receive sections include all on-chip filtering, mixing, and gain control functions.

Ten RF control signals are available to drive external RF switches. See the reference board schematics for more information.

A block diagram of the radio subsystem is shown in Figure 10. Note that integrated on-chip baluns (not shown) convert the fully differential transmit and receive paths to single-ended signal pins.

8.1 Receiver Path

The CYW43903 has a wide dynamic range, direct conversion receiver that employs high-order on-chip channel filtering to ensure reliable operation in the noisy 2.4 GHz ISM band. The 2.4 GHz path has a dedicated on-chip low-noise amplifier (LNA).

8.2 Transmit Path

Baseband data is modulated and upconverted to the 2.4 GHz ISM band. Linear on-chip power amplifiers deliver high output powers while meeting IEEE 802.11b/g/n specifications without the need for external PAs. When using the internal PA, which is required in the 2.4 GHz band, closed-loop output power control is completely integrated.

8.3 Calibration

The CYW43903 features dynamic and automatic on-chip calibration to continually compensate for temperature and process variations across components. These calibration routines are performed periodically during the course of normal radio operation. Examples of some of the automatic calibration algorithms are baseband filter calibration for optimum transmit and receive performance and LOFT calibration for carrier leakage reduction. In addition, I/Q calibration and VCO calibration are performed on-chip. No per-board calibration is required during manufacturing testing. This helps to minimize the test time and cost in large-volume production environments.

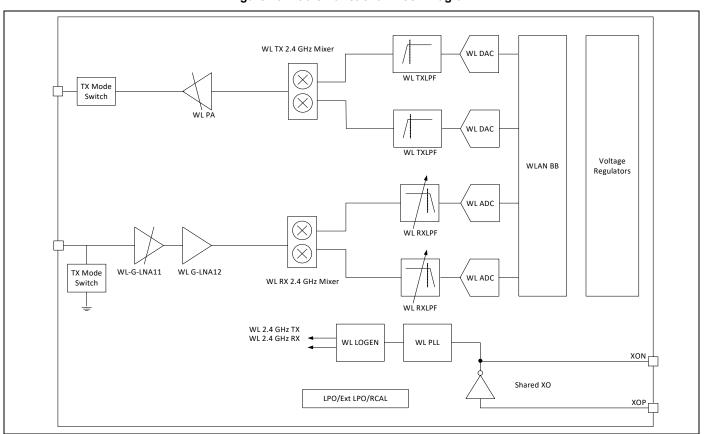


Figure 10. Radio Functional Block Diagram

PRELIMINARY

CYW43903



9. Pinout and Signal Descriptions

9.1 Ball Map

Figure 11. 151-Ball WLBGA Map—Top View with Balls Facing Down

	12	7	10	6	∞	7	9	ıs	4	ო	7	-	ī
∢	SR_PVSS	SR_VLX	WL_REG_ON	VDDC	VDDIO	UART0_CTS	SFL_CS	SFL_CLK	SFL_IO0	GPIO_14	GPIO_15		٧
æ	SR_ VDDBAT5V	VOUT_CLDO	VOUT_ CLDO_SENSE	I2C0_SDATA	UART0_TXD	UART0_RTS	SPI0_SISO	SPI0_CLK	SFL_IO2	SFL_I01	VSSC	GPIO_11	В
U	LDO_ VDD1P5	VOUT_ HSICLDO	PMU_AVSS	VSSC	I2C0_CLK	UART0_RXD	GP10_12	SPI0_MISO	SFL_IO3	VSSC	GP10_16	GPIO_10	o
Q	LDO_ VDDBAT5V	VOUT_LNLDO	VSSC	GPIO_8	VSSC	VSSC			VDDC	VDDC	VSSC	GPIO_1	Q
ш	VOUT_3P3	OIGGA	OIGGA	OIGGA	GPIO_13		SD_0IAS	Z_0I9D		NSSC	6 Old5	0 ⁻ 0Id9	ш
L	9_OI9D	GPIO_5	4_OIPD_4	OSSA	OSSA		VSSC	VDDC			NDDC	VDDC	ш
g	GPIO_3	NC_G11	2_OP1O_2	OSSA		VSSC	VDDC		OSSA	VSSC	VSSC	HIB_VDDO	ອ
I	NC_H12	VDDC	OSSA	6H¯ON		VDDC		VDDC		HIB_WAKE_B	HIB_XTALIN	HIB_REG_ON_O UT	н
7	NC_J12	NC_J11	OLC_J10	OSSA	OIGGA		VSSC	NSSC		HIB_LPO_ SELMODE	HIB_XTALOUT	VDDC	7
×	PWR_GND	VSSC	RF_SW_ CTRL_6	VDDIO_RF	VDDIO_RF	VDDIO	VDDC	VDDC	OSSA	HIB_REG_ ON_IN	VSSC	VSSC	¥
	RF_SW_ CTRL_7	RF_SW_ CTRL_1	Saav	RF_SW_ CTRL_4	OSSA	VDDC	WRF_SYNTH_ VDD3P3	WRF_VCO_ GND	WRF_EXT_ TSSIA	WRF_GPAIO_ OUT	WRF_RX2G_ GND	WRF_RFIN_ 2G	7
Σ	RF_SW_ CTRL_8	VSSC	RF_SW_ CTRL_5	RF_SW_ CTRL_0	LPO_XTAL_IN	AVSS	WRF_XTAL_ VDD1P2	WRF_SYNTH_ GND	WRF_GENERAL _GND	WRF_AFE_ GND	WRF_TXMIX_ VDD	WRF_ PAOUT_2G	×
z	VBDIO	RF_SW_ CTRL_9	NC_N10	RF_SW_ CTRL_3	AVDD1P2	WRF_XTAL_ GND1P2	WRF_XTAL_ VDD1P35	WRF_SYNTH_ VDD1P2	WRF_AFE_ VDD1P35	WRF_GENERAL 2_GND	WRF_PA_ GND3P3		z
۵		SRSTN	JTAG_SEL	RF_SW_ CTRL_2	отр_уррзрз	WRF_XTAL_ XON	WRF_XTAL_ XOP	WRF_PMU_ VDD1P35	WRF_RX5G_ GND	RF_GND_P3	RF_GND_P2	WRF_PA_ VDD3P3	Ф
	12	Ξ	10	6	80	7	9	2	4	က	7	-	



9.2 Ball List

Table 7 contains the 151-ball WLBGA net names.

Table 7. WLBGA Net Names

Ball	Net Name
A2	GPIO_15
A3	GPIO_14
A4	SFL_IO0
A5	SFL_CLK
A6	SFL_CS
A7	UART0_CTS
A8	VDDIO
A9	VDDC
A10	REG_ON
A11	SR_VLX
A12	SR_PVSS
B1	GPIO_11
B2	VSSC
В3	SFL_IO1
B4	SFL_IO2
B5	SPI0_CLK
B6	SPI0_SISO
B7	UART0_RTS
B8	UART0_TXD
В9	I2C0_SDATA
B10	VOUT_CLDO_SENSE
B11	VOUT_CLDO
B12	SR_VDDBAT5V
C1	GPIO_10
C2	GPIO_16
C3	VSSC
C4	SFL_IO3
C5	SPI0_MISO
C6	GPIO_12
C7	UART0_RXD
C8	I2C0_CLK
C9	VSSC
C10	PMU_AVSS
C11	VOUT_HSICLDO
C12	LDO_VDD1P5
D1	GPIO_1
D2	VSSC
D3	VDDC
D4	VDDC
D7	VSSC

Ball	Net Name
D8	VSSC
D9	GPIO_8
D10	VSSC
D11	VOUT_LNLDO
D12	LDO_VDDBAT5V
E1	GPIO_0
E2	GPIO_9
E3	VSSC
E5	GPIO_7
E6	SPI0_CS
E8	GPIO_13
E9	VDDIO
E10	VDDIO
E11	VDDIO
E12	VOUT_3P3
F1	VDDC
F2	VDDC
F5	VDDC
F6	VSSC
F8	VSSC
F9	VSSC
F10	GPIO_4
F11	GPIO_5
F12	GPIO_6
G1	HIB_VDDO
G2	VSSC
G3	VSSC
G4	VSSC
G6	VDDC
G7	VSSC
G9	VSSC
G10	GPIO_2
G11	NC_G11
G12	GPIO_3
H1	HIB_REG_ON_OUT
H2	HIB_XTALIN
H3	HIB_WAKE_B
H5	VDDC
H7	VDDC
H9	NC_H9



Ball	Net Name
H10	VSSC
H11	VDDC
H12	NC_H12
J1	VDDC
J2	HIB_XTALOUT
J3	HIB_LPO_SELMODE
J5	VSSC
J6	VSSC
J8	VDDIO
J9	VSSC
J10	NC_J10
J11	NC_J11
J12	NC_J12
K1	VSSC
K2	VSSC
K3	HIB_REG_ON_IN
K4	VSSC
K5	VDDC
K6	VDDC
K7	VDDIO
K8	VDDIO_RF
K9	VDDIO_RF
K10	RF_SW_CTRL_6
K11	VSSC
K12	PWR_GND
L1	WRF_RFIN_2G
L2	WRF_AFE_GND
L3	WRF_GPAIO_OUT
L4	WRF_EXT_TSSIA
L5	WRF_AFE_GND
L6	WRF_SYNTH_VDD3P3
L7	VDDC
L8	VSSC
L9	RF_SW_CTRL_4
L10	VDDC
L11	RF_SW_CTRL_1
L12	RF_SW_CTRL_7
M1	WRF_PAOUT_2G
M2	WRF_TXMIX_VDD
M3	WRF_AFE_GND
M4	WRF_AFE_GND
M5	WRF_AFE_GND
M6	WRF_XTAL_VDD1P2

Ball	Net Name
M7	AVSS
M8	LPO_XTAL_IN
M9	RF_SW_CTRL_0
M10	RF_SW_CTRL_5
M11	VSSC
M12	RF_SW_CTRL_8
N2	WRF_AFE_GND
N3	WRF_AFE_GND
N4	WRF_AFE_VDD1P35
N5	WRF_SYNTH_VDD1P2
N6	WRF_XTAL_VDD1P35
N7	WRF_AFE_GND
N8	AVDD1P2
N9	RF_SW_CTRL_3
N10	NC_N10
N11	RF_SW_CTRL_9
N12	VDDIO
P1	WRF_PA_VDD3P3
P2	RF_GND_P2
P3	RF_GND_P3
P4	WRF_AFE_GND
P5	WRF_PMU_VDD1P35
P6	WRF_XTAL_XOP
P7	WRF_XTAL_XON
P8	OTP_VDD3P3
P9	RF_SW_CTRL_2
P10	JTAG_SEL
P11	SRSTN



9.3 Signal Descriptions

Table 8 provides the signal name, type, and description for each CYW43903 ball. The symbols shown under Type indicate pin directions (I/O = bidirectional, I = input, and O = output) and the internal pull-up/pull-down characteristics (PU = weak internal pull-up resistor and PD = weak internal pull-down resistor), if any.

Table 8. Signal Descriptions

Ball Number	Signal Name	Туре	Description
	Cypress Serial Cor	ntrol (CS	SC) Interfaces
C8	I ² C0_CLK	0	CSC master clock.
B9	I ² C0_SDATA	I/O	CSC serial data
	Cl	ocks	
P6	WRF_XTAL_XOP	I	XTAL oscillator input.
P7	WRF_XTAL_XON	0	XTAL oscillator output.
M8	LPO_XTAL_IN	I	External sleep clock input (32.768 kHz).
H2	HIB_XTALIN	1	3.3V 32 kHz crystal input
J2	HIB_XTALOUT	0	3.3V 32 kHz crystal output
	GPIO Inter	face (W	LAN)
E1	GPIO_0	I/O	
D1	GPIO_1	I/O	
G10	GPIO_2	I/O	
G12	GPIO_3	I/O	
F10	GPIO_4	I/O	
F11	GPIO_5	I/O	Programmable GPIO pins.
F12	GPIO_6	I/O	Trogrammable of to pine.
E5	GPIO_7	I/O	
D9	GPIO_8	I/O	
E2	GPIO_9	I/O	
C1	GPIO_10	I/O	
B1	GPIO_11	I/O	
C6	GPIO_12	I/O	
E8	GPIO_13	I/O	
A3	GPIO_14	I/O	
A2	GPIO_15	I/O	
C2	GPIO_16	I/O	
	Gr	ound	
L2, L5, M3, M4, M5, N2, N3, N7, P4	WRF_AFE_GND	GND	AFE ground
M11, K11, H10, D10, J9, G9, F9, C9, L8, F8, D8, G7, D7, J6, F6, J5, K4, G4, G3, E3, C3, K2, G2, D2, B2, K1	VSSC	GND	Core ground for WLAN and APP sections
A12	SR_PVSS	GND	Power ground
C10	PMU_AVSS	GND	Quiet ground
M7	AVSS	GND	Baseband PLL ground



Table 8. Signal Descriptions (Cont.)

Ball Number	Signal Name	Туре	Description
	Hibernation Block, Power	-Down/F	Power-Up, and Reset
A10	REG_ON	I	Used by PMU to power up or power down the internal CYW43903 regulators used by the WLAN and APP sections. Also, when deasserted, this pin holds the WLAN and APP sections in reset. This pin has an internal 200 k Ω pull-down resistor that is enabled by default. It can be disabled through programming.
К3	HIB_REG_ON_IN	I	Used by the hibernation block to power up or power down the internal CYW43903 regulators. For applications that use the hibernation block, HIB_REG_ON_OUT must connect to REG_ON. Also, when deasserted, this pin holds the WLAN and APP sections in reset.
H1	HIB_REG_ON_OUT	0	REG_ON output signal generated by the hibernation block.
H3	HIB_WAKE_B	1	Wake up chip from hibernation mode.
J3	HIB_LPO_SELMODE	1	Select precise or coarse 32 kHz clock.
P11	SRSTN	I	System reset. This active-low signal resets the backplanes.
	JTAG	Interfac	e
P10	JTAG_SEL	I	JTAG select. This pin must be connected to ground if the JTAG interface is not used.
	No Co	onnects	
J10, J11, J12, H9, H12, G11, N10, L4	NC_J10, NC_J11, NC_J12, NC_H9, NC_H12, NC_G11, NC_N10, WRF_EXT_TSSIA	_	No connect
	Power Supplies	s (Misce	ellaneous)
P8	OTP_VDD3P3	PWR	OTP 3.3V supply
H11, L10, A9, L7, H7, K6, G6, K5, H5, F5, D4, D3, F2, J1, F1	VDDC	PWR	1.2V core supply for WLAN
N12, E11, E10, E9, J8, A8, K7	VDDIO	PWR	I/O supply
K8, K9	VDDIO_RF	PWR	I/O supply for RF switch control pads (3.3V).
K12	PWR_GND	GND	Power supply ground
G1	HIB_VDDO	PWR	I/O supply for hibernation block
N8	AVDD1P2	PWR	1.2V supply for baseband PLL
	Power Sup	plies (W	/LAN)
L6	WRF_SYNTH_VDD3P3	PWR	Synthesizer VDD 3.3V supply
P1	WRF_PA_VDD3P3	PWR	2.4 GHz PA 3.3V VBAT supply
P5	WRF_PMU_VDD1P35	PWR	PMU 1.35V supply
M2	WRF_TXMIX_VDD	PWR	3.3V supply for TX mixer
N5	WRF_SYNTH_VDD1P2	PWR	1.2V supply for synthesizer
N4	WRF_AFE_VDD1P35	PWR	1.35V supply for the analog front end (AFE)
	PWM Interface (Altern	ate Fun	ction for GPIOs)
_	PWM0	0	Pulse width modulation bit 0.
_	PWM1	0	Pulse width modulation bit 1
_	PWM2	0	Pulse width modulation bit 2
_	PWM3	0	Pulse width modulation bit 3



Table 8. Signal Descriptions (Cont.)

Ball Number	Signal Name	Туре	Description
-	PWM4	0	Pulse width modulation bit 4
_	PWM5	0	Pulse width modulation bit 5
	RF Signa	I Interface	(WLAN)
L1	WRF_RFIN_2G	ı	2.4 GHz WLAN receiver input
P3	RF_GND_P3	GND	RF ground
M1	WRF_PAOUT_2G	0	2.4 GHz WLAN PA output
P2	RF_GND_P2	GND	RF ground
L3	WRF_GPAIO_OUT	I/O	Analog GPIO
	RF Swit	ch Control	Lines
M9	RF_SW_CTRL_0	0	Programmable RF switch control lines. The control lines
L11	RF_SW_CTRL_1	0	are programmable via the driver and nvram.txt file.
P9	RF_SW_CTRL_2	0	
N9	RF_SW_CTRL_3	0	
L9	RF_SW_CTRL_4	0	
M10	RF_SW_CTRL_5	I/O	
K10	RF_SW_CTRL_6	I/O	
L12	RF_SW_CTRL_7	I/O	
M12	RF_SW_CTRL_8	I/O	
N11	RF_SW_CTRL_9	I/O	
	SPI F	lash Interf	ace
A5	SFL_CLK	0	Flash clock
A4	SFL_IO0	I/O	Flash data
B3	SFL_IO1	I/O	Flash data
B4	SFL_IO2	I/O	Flash data
C4	SFL_IO3	I/O	Flash data
A6	SFL_CS	0	Flash slave select
	SI	PI Interface	
Note: The SPI interface can	alternatively be configured and	used as a C	CSC interface.
B5	SPI0_CLK	0	SPI clock
C5	SPI0_MISO	I	SPI data master in
B6	SPI0_SISO	0	SPI data master out
E6	SPI0_CS	0	SPI slave select
	UA	RT Interfac	ee
A7	UART0_CTS	1	UART clear-to-send
B7	UART0_RTS	0	UART request-to-send
C7	UART0_RXD	1	UART serial input
B8	UART0_TXD	0	UART serial output
	Voltage Re	gulators (In	itegrated)
B12	SR_VDDBAT5V	I	VBAT.
A11	SR_VLX	0	CBUCK switching regulator output



Table 8. Signal Descriptions (Cont.)

Ball Number	Signal Name	Туре	Description
C12	LDO_VDD1P5	I	LNLDO input
D12	LDO_VDDBAT5V	I	LDO VBAT
N6	WRF_XTAL_VDD1P35	I	XTAL LDO input (1.35V)
M6	WRF_XTAL_VDD1P2	0	XTAL LDO output (1.2V)
D11	VOUT_LNLDO	0	Terminate with 2.2 μF capacitor to GND
B11	VOUT_CLDO	0	Output of core LDO
E12	VOUT_3P3	0	LDO 3.3V output
B10	VOUT_CLDO_SENSE	0	Voltage sense pin for core LDO
C11	VOUT_HSICLDO	0	Output of HSIC LDO

Document Number: 002-14826 Rev. *G Page 33 of 65



10. GPIO Signals and Strapping Options

10.1 Overview

This section describes GPIO signals and strapping options. The pins are sampled at power-on reset (POR) to determine various operating modes. Sampling occurs a few milliseconds after an internal POR or deassertion of the external POR. After the POR, each pin assumes the GPIO or alternative function specified in Table 10. Each strapping option pin has an internal pull-up (PU) or pull-down (PD) resistor that determines the default mode. To change the mode, connect an external PU resistor to VDDIO or a PD resistor to ground, using a 10 k Ω resistor or less.

Note: Refer to the reference board schematics for more information.

10.2 Weak Pull-Down and Pull-Up Resistances

At VDDO = 3.3V $\pm 10\%$, the minimum, typical, and maximum weak pull-down resistances (for a pin voltage of VDDO) are 37.99 k Ω , 44.57 k Ω , and 51.56 k Ω , respectively. At VDDO = 3.3V $\pm 10\%$, the minimum, typical, and maximum weak pull-up resistances (for a pin voltage of 0V) are 34.73 k Ω , 39.58 k Ω , and 44.51 k Ω , respectively.

10.3 Strapping Options

Table 9 provides the strapping options.

Table 9. Strapping Options

Pin Name	Strap	#	Default Internal Pull During Strap	Description
GPIO_1	GSPI_MODE	D1	PD	Enable gSPI interface
GPIO_7	WCPU_BOOT_MODE	E5	PD	Boot from SoC SROM or SoC SRAM
GPIO_11	ACPU_BOOT_MODE	B1	PD	Boot from tightly coupled memory (TCM) ROM or TCM RAM
GPIO_13	SDIO_MODE	E8	PD	Select either SDIO host mode or SDIO device mode
GPIO_15	VTRIM_EN	A2	PD	Enable PMU voltage trimming
RF_SW_CTRL_5	DAP_CLK_SEL	M10	PD	Select XTAL clock or the test clock (tck) for the debug access port (DAP)
RF_SW_CTRL_7	RSRC_INIT_MODE	L12	PD	PMU resource initialization mode selection

Document Number: 002-14826 Rev. *G Page 34 of 65



10.4 Alternate GPIO Signal Functions

Table 10 provides the alternate signal functions of the GPIO signals.

Table 10. Alternate GPIO Signal Functions

GPIO	Default	JTAG_SEL	Default Pull	HOLD/PDLOW/ PDHIGH	Strap	Comments
GPIO_0	_	_	No pull	HOLD	-	8 mA
GPIO_1	_	_	Down	HOLD	GSPI_MODE	8 mA
GPIO_2	GCI_GPIO(0)	JTAG_TCK	No pull	HOLD	_	8 mA
GPIO_3	GCI_GPIO(1)	JTAG_TMS	No pull	HOLD	_	8 mA
GPIO_4	GCI_GPIO(2)	JTAG_TDI	No pull	HOLD	_	8 mA
GPIO_5	GCI_GPIO(3)	JTAG_TDO	No pull	HOLD	_	8 mA
GPIO_6	GCI_GPIO(4)	JTAG_TRST	No pull	HOLD	_	8 mA
GPIO_7	_	_	Down	HOLD	WCPU_BOOT_MODE	8 mA
GPIO_8	GPIO_8	_	No pull	HOLD	_	8 mA
GPIO_9	GPIO_9	_	Down	HOLD		8 mA
GPIO_10	GPIO_10	_	No pull	HOLD	_	8 mA
GPIO_11	_	_	Down	HOLD	ACPU_BOOT_MODE	8 mA
GPIO_12	GPIO_12	_	No pull	HOLD	_	8 mA
GPIO_13	_	_	Down	HOLD	SDIO_MODE	8 mA
GPIO_14	GPIO_14	_	No pull	HOLD	_	8 mA
GPIO_15	_	_	Down	HOLD	VTRIM_EN	8 mA
GPIO_16	_	_	No pull	HOLD	_	8 mA

Document Number: 002-14826 Rev. *G Page 35 of 65

PRELIMINARY



11. Pin Multiplexing

Table 11 shows the pin multiplexing functions.

Table 11. Pin Multiplexing

						Function					
Pin	-	2	ო	4	2	9	2	80	6	10	7
3PIO_0	GPIO_0	UART0_RXD	I ² C1_SDATA	PWM0	SPI1_MISO	PWM2	GPIO_12	GPIO_8	ı	PWM4	ı
GPIO_1	GPIO_1	UART0_TXD	I ² C1_CLK	PWM1	SPI1_CLK	PWM3	GPIO_13	G_OIQ_9	ı	PWM5	ı
GPIO_2	GPIO_2	1	1	GCI_GPIO_0	ı	ı	1	1	TCK	1	1
GPIO_3	GPIO_3	ı	ı	GCI_GPIO_1	I	I	1	ı	TMS	I	ı
GPIO_4	GPIO_4	1	1	GCI_GPIO_2	ı	ı	1	1	IQL	1	1
	GPIO_5	ı	ı	GCI_GPIO_3	I	I	I	1	ТБО	1	ı
	GPIO_6	I	ı	GCI_GPIO_4	I	I	ı	ı	TRST_L	I	ı
GPIO_7	GPIO_7	UART0_ RTS_OŪT	PWM1	PWM3	SPI1_CS	I2C1_CLK	GPIO_15	GPIO_11	PMU_TEST_ O	I	PWM5
GPIO_8	GPIO_8	SPI1_MISO	PWM2	PWM4	UARTO_RXD	ı	GPIO_16	GP10_12	TAP_SEL_P	12C1_SDATA	PWM0
G_OIAO_9	G_OIG_9	SPI1_CLK	PWM3	PWM5	UART0_TXD	1	GPIO_0	GP10_13	ı		PWM1
GPIO_10	GPIO_10	SPI1_MOSI	PWM4	l ² C1_SDATA	UARTO_ CTS_IN	PWM0	GPIO_1	GPIO_14	PWM2	I	ı
GPIO_11	GPIO_11	SP11_CS	PWM5	l ² C1_CLK	UART0 RTS_OŪT	PWM1	GPIO_7	GPIO_15	PWM3	I	ı
GPIO_12	GPIO_12	l ² C1_SDATA	UARTO_RXD	SPI1_MISO	PWM2	PWM4	GPIO_8	GP10_16	PWM0	I	ı
GPIO_13	GPIO_13	I ² C1_CLK	UART0_TXD	SP11_CLK	PWM3	PWM5	G_OIG_9	GPIO_0	PWM1	I	ı
GPIO_14	GPIO_14	PWM0	UART0_ CTS_IN	SPI1_MOSI	l ² C1_SDATA	I	GPIO_10	I	PWM4	_	PWM2
GPIO_15	GPIO_15	PWM1	UART0 RTS_OŪT	SPI1_CS	I ² C1_CLK	I	GPIO_11	GPIO_7	PWM5	I	PWM3
GPIO_16	GPIO_16	UART0_ CTS_IN	PWM0	PWM2	SPI1_MOSI	l ² C1_SDATA	GPIO_14	GPIO_10	RF DISABLE_L	_	PWM4
	RF_SW_ CTRL_5	GCI_GPIO_5	I	I	I	I	_	I	ı	-	
RF_SW_ CTRL_6	RF_SW_ CTRL_6	UART_ DBG_RX ¹	SECI_IN ¹	I	I	I	_	I	I	I	ı
RF_SW_ CTRL_7	RF_SW_ CTRL_7	UART_ DBG_TX ¹	SECI_OUT1	I	I	I	1	I	I	I	I

Page 36 of 65

CYW43903



Table 11. Pin Multiplexing

						Function					
Pin	7	2	က	4	9	9	7	8	6	10	11
RF_SW_ CTRL_8	RF_SW_ CTRL_8	SECI_IN1	UART_ DBG_RX ¹	I	I	ı	ı	1	1	1	
RF_SW_ CTRL_9	RF_SW_ CTRL_9	SECI_OUT1	UART_ DBG_TX ¹	I	I	I	I	I	I	ı	
SPI0_MISO	SPI0_MISO SPI0_MISO GPIO_17	GPIO_17	GPIO_24	1	1	ı	1	1	ı	_	1
SPI0_CLK	SPI0_CLK	GPIO_18	GPIO_25	ı	_	ı	1	1	ı	_	ı
SPIO_MOSI	SPI0_MOSI SPI0_MOSI GPIO_19	GPIO_19	GPIO_26	ı	-	ı	1	1	ı	_	1
SPIO_CS	SPI0_CS	GPIO_20	GPIO_27	1	_	1	-	-	ı	_	
I ² CO_SDATA	CO_SDATA CO_SDATA GPIO_21	GPIO_21	GPIO_28	I	-	-	_	_	_	_	1
12C0_CLK	² C0_CLK ² C0_CLK GPIO_22	GPIO_22	GPIO_29	_	_	_	_	_	_	_	
A HOW I			TO SEE TO SEE SEE SEE SEE SEE SEE SEE SEE SEE SE		4 d	5 The section of the		CTO ALL	7 3		

^{1.} UART_DBG_TX and UART_DBG_RX are for UART1 mentioned in section 5.7 and in the reference schematics. SECI_IN and SECI_OUT are for UART2 mentioned in section 5.7 and in the reference schematics.



12. I/O States

Table 12 provides I/O state information for the signals listed.

The following notations are used in Table 12:

I: Input signal

O: Output signal

I/O: Input/Output signal

■ PU = Pulled up

■ PD = Pulled down

■ NoPull = Neither pulled up nor pulled down

Table 12. I/O States

Ball Name	<u>8</u>	Keeper ¹	Active Mode	Low Power State/Sleep (All Power Present)	Power-down ² (REG_ON Held Low)	Out-of-Reset; Before Software Download (REG_ON High)	Power Rail
HIB_REG_ON_IN	_	z	Input; PD (Pull-down can be disabled.)	Input; PD (Pull-down can be disabled.)	Input	Input	ı
REG_ON I	_	z	Input; PD (Pull-down can be disabled.)	Input; PD (Pull-down can be disabled.)	Input; PD (of 200 kΩ)	Input; PD (of 200 kΩ)	I
GPIO_0	0/1	>	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	High-Z, NoPull	Input; PD	VDDIO
GPIO_1	0/1	>	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_2	0/1	>	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_3	<u>Q</u>	>	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	High-Z, NoPull	Input; PD	VDDIO
GPIO_4	0/1	>	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_5	0/1	>	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	High-Z, NoPull	Input; PD	VDDIO

Page 38 of 65

CYW43903



Table 12. I/O States

Ball Name	<u>8</u>	Keeper ¹	Active Mode	Low Power State/Sleep (All Power Present)	Power-down ² (REG_ON Held Low)	Out-of-Reset; Before Software Download (REG_ON High)	Power Rail
GPIO_6	0/1	>	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_7	0/1	>	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_8	0/1	\	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	High-Z, NoPull	Input; PD	VDDIO
GPIO_9	0/1	\	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	High-Z, NoPull	Input; PD	VDDIO
GPIO_10	0/1	\	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_11	0/1	\	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	Input/Output; PU, PD, or NoPull (programmable [Default: PD])	High-Z, NoPull	Input; PD	VDDIO
GPIO_12	0/1	\	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_13	0/1	\	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_14	0/1	\	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_15	0/1	\	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
GPIO_16	0/1	\	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	Input/Output; PU, PD, or NoPull (programmable [Default: NoPull])	High-Z, NoPull	Input; NoPull	VDDIO
RF_SW_CTRL (0 to 9)	1/0	Υ	Output; NoPull	Output; NoPull	High-Z	Output; NoPull	VDDIO_RF

^{1.} Keeper column: N = pad has no keeper. Y = pad has a keeper. Keeper is always active except in power-down state. If there is no keeper, and it is an input and there is NoPull, then the pad should be driven to prevent leakage due to floating pad (WL_REG_ON, for example).

^{2.} In the power-down state (xx_REG_ON=0): High-Z; NoPull => the pad is disabled because power is not supplied.



13. Electrical Characteristics

Note: Values in this data sheet are design goals and are subject to change based on the results of device characterization.

13.1 Absolute Maximum Ratings

Caution! The absolute maximum ratings in Table 13 indicate levels where permanent damage to the device can occur, even if these limits are exceeded for only a brief duration. Functional operation is not guaranteed under these conditions. Operation at absolute maximum conditions for extended periods can adversely affect long-term reliability of the device.

Table 13. Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
DC supply for VBAT and PA driver supply ¹	VBAT	-0.5 to +5.5	V
DC supply voltage for digital I/O	VDDIO	-0.5 to 3.9	V
DC supply voltage for RF switch I/O	VDDIO_RF	-0.5 to 3.9	V
DC input supply voltage for CLDO, LNLDO, and LDO ²	_	-0.5 to 1.575	V
3.3V DC supply voltage for RF analog ³	VDD3P3RF	-0.5 to 3.6	V
1.35V DC supply voltage for RF analog ⁴	VDD1P35RF	-0.5 to 1.5	V
1.2V DC supply voltage for RF analog ⁵	VDD1P2RF	-0.5 to 1.26	V
1.2V DC supply voltage for analog circuits ⁶	VDD1P2A	-0.5 to 1.26	V
DC supply voltage for the core ⁷	VDDC	-0.5 to 1.32	V
DC supply voltage for OTP memory	OTP_VDD3P3	-0.5 to 3.9	V
Maximum undershoot voltage for I/O	V _{undershoot}	-0.5	V
Maximum junction temperature	Tj	125	°C

^{1.} For the SR_VDDBAT5V and LDO_VDDBAT5V supplies.

Document Number: 002-14826 Rev. *G Page 40 of 65

^{2.} For the LDO_VDD1P5 and WRF_XTAL_VDD1P35 supplies.

^{3.} For the WRF_SYNTH_VDD3P3, WRF_PA_VDD3P3, and WRF_TXMIX_VDD supplies.

^{4.} For WRF_PMU_VDD1P35 and WRF_AFE_VDD1P35 supplies.

^{5.} For the WRF_SYNTH_VDD1P2 supply.

^{6.} For the AVDD1P2 supply.

^{7.} For the VDD supply.



13.2 Environmental Ratings

The environmental ratings are shown in Table 14.

Table 14. Environmental Ratings

Characteristic	Value	Units	Conditions/Comments
Ambient temperature (T _A)	-30 to +85	°C	Functional operation
Storage temperature	-40 to +125	°C	_
Relative humidity	Less than 60	%	Storage
	Less than 85	%	Operation

13.3 Electrostatic Discharge Specifications

Extreme caution must be exercised to prevent electrostatic discharge (ESD) damage. Proper use of wrist and heel grounding straps to discharge static electricity is required when handling these devices. Always store unused material in its antistatic packaging.

Table 15. ESD Specifications

Pin Type	Symbol	Condition	ESD Rating	Unit
ESD	ESD_HAND_HBM	Human body model contact discharge per JEDEC EID/JESD22-A114	1.5 k	V
CDM	ESD_HAND_CDM	Charged device model contact discharge per JEDEC EIA/JESD22-C101	250	V

13.4 Recommended Operating Conditions and DC Characteristics

Caution! Functional operation is not guaranteed outside of the limits shown in Table 16. Operation outside these limits for extended periods can adversely affect long-term reliability of the device.

Table 16. Recommended Operating Conditions and DC Characteristics

			Value		
Parameter	Symbol	Minimum	Typical	Maximum	Unit
DC supply voltage for VBAT	VBAT	2.3 ¹	3.6	4.8	V
DC supply voltage for digital I/O	VDDIO	1.71	_	3.63	٧
DC supply voltage for RF switch I/Os	VDDIO_RF ²	3.13	3.3	3.6	V
DC input supply voltage for CLDO, LNLDO, and LDO	-	1.3	1.35	1.5	V
3.3V DC supply voltage for RF analog	VDD3P3RF ³	3	3.3	3.45	V
1.35V DC supply voltage for RF analog	VDD1P35RF ³	1.3	1.35	1.5	V
1.2V DC supply voltage for RF analog	VDD1P2RF ³	1.1	1.2	1.26	V
1.2V DC supply voltage for analog	VDD1P2A ³	1.1	1.2	1.26	V
DC supply voltage for core	VDDC	1.14	1.2	1.26	V
DC supply voltage for OTP memory	OTP_VDD3P3 ²	2.97	3.3	3.63	V
DC supply voltage for TCXO input buffer	WRF_TCXO_VDD3	1.62	1.8	1.98	V
Internal POR threshold	Vth_POR	0.4	_	0.7	V

Document Number: 002-14826 Rev. *G Page 41 of 65



Table 16. Recommended Operating Conditions and DC Characteristics (Cont.)

			Value		
Parameter	Symbol	Minimum	Typical	Maximum	Unit
	Other Digital I/O Pins				
For VDDIO = 1.8V:					
Input high voltage	VIH	0.65 × VDDIO	_	_	V
Input low voltage	VIL	_	_	0.35 × VDDIO	٧
Output high voltage @ 2 mA	VOH	VDDIO – 0.45	_	_	V
Output low voltage @ 2 mA	VOL	_	_	0.45	V
For VDDIO = 3.3V:					
Input high voltage	VIH	2.00	-	_	V
Input low voltage	VIL	_	-	0.80	V
Output high voltage @ 2 mA	VOH	VDDIO – 0.4	_	_	V
Output low voltage @ 2 mA	VOL	_	-	0.40	V
RF Sw	ritch Control Output Pir	ıs ⁴			
For VDDIO_RF = 3.3V:					
Output high voltage @ 2 mA	VOH	VDDIO – 0.4	_	_	V
Output low voltage @ 2 mA	VOL	_	_	0.40	٧
Input capacitance	C _{IN}	_	_	5	pF

^{1.} The CYW43903 is functional across this range of voltages. Optimal RF performance specified in the data sheet, however, is guaranteed only for 3V < VBAT < 4.8V.

^{2.} VDD3P3RF, which is an internally generated supply, can drive this node. There is sufficient current and the appropriate state is maintained during hibernation and sleep cycles.

^{3.} Internally generated supply.

^{4.} Programmable 2 mA to 16 mA drive strength. Default is 10 mA.



13.5 Power Supply Segments

The digital I/O's are placed in physical segments. The supply voltage for each segment can be independently selected.

Table 17 shows the power supply segments and the I/O pins associated with each segment.

Table 17. Power Supply Segments

Power Supply Segment	Pins
VDDIO	GPIO_0, GPIO_1, GPIO_2, GPIO_3, GPIO_4, GPIO_5, GPIO_6, GPIO_7, GPIO_8, GPIO_9, GPIO_10, GPIO_11, GPIO_12, GPIO_13, GPIO_14, GPIO_15, GPIO_16, I2C0_CLK, I2C0_SDATA, I2C1_CLK, I2C1_SDATA, JTAG_SEL, SFL_CLK, SFL_CS, SFL_IO0, SFL_IO1, SFL_IO2, SFL_IO3, SPI0_CLK, SPI0_CS, SPI0_MISO, SPI0_SISO, SPI1_CLK, SPI1_CS, SPI1_MISO, SPI1_SISO, SRSTN, UART0_CTS, UART0_RXD, UART0_TXD
VDDIO_RF	RF_SW_CTRL_0, RF_SW_CTRL_1, RF_SW_CTRL_2, RF_SW_CTRL_3, RF_SW_CTRL_4, RF_SW_CTRL_5, RF_SW_CTRL_6, RF_SW_CTRL_7, RF_SW_CTRL_8, RF_SW_CTRL_9

13.6 GPIO, UART, and JTAG Interfaces DC Characteristics

Table 18. GPIO, UART, and JTAG Interfaces

Parameter	Symbol	Minimum	Maximum	Units	Conditions
Logic input high voltage	V _{IH}	2.0	VDDIO + 0.5	V	_
Logic input low voltage	V _{IL}	-0.5	0.8	V	_
Logic output high voltage	V _{OH}	2.4	_	V	-
Logic output low voltage	V _{OL}	_	0.4	V	-

Document Number: 002-14826 Rev. *G Page 43 of 65



14. WLAN RF Specifications

14.1 Introduction

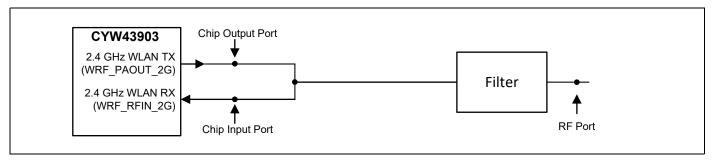
The CYW43903 includes an integrated direct conversion radio that supports the 2.4 GHz band. This section describes the RF characteristics of the 2.4 GHz radio.

Note: Values in this section of the data sheet are design goals and are subject to change based on device characterization results.

Unless otherwise stated, limit values apply for the conditions specified in Table 14, "Environmental Ratings," and Table 16, "Recommended Operating Conditions and DC Characteristics,". Typical values apply for the following conditions:

- VBAT = 3.6V
- Ambient temperature +25°C

Figure 12. Port Locations for WLAN Testing



14.2 2.4 GHz Band General RF Specifications

Table 19. 2.4 GHz Band General RF Specifications

Item	Condition	Minimum	Typical	Maximum	Unit
TX/RX switch time	Including TX ramp down	_	_	5	μs
RX/TX switch time	Including TX ramp up	_	_	2	μs
Power-up and power-down ramp time	DSSS/CCK modulations	_	_	< 2	μs



14.3 WLAN 2.4 GHz Receiver Performance Specifications

Note: The specification shown in Table 20 apply at the chip ports, unless otherwise defined.

Table 20. WLAN 2.4 GHz Receiver Performance Specifications

Parameter	Condition/Notes	Minimum	Typical	Maximum	Unit
Frequency range	-	2400	_	2500	MHz
RX sensitivity IEEE 802.11b	1 Mbps DSSS	_	-98.9	_	dBm
(8% PER for 1024 octet PSDU)	2 Mbps DSSS	_	-96.0	_	dBm
	5.5 Mbps DSSS	_	-93.9	_	dBm
	11 Mbps DSSS	_	-90.4	_	dBm
RX sensitivity IEEE 802.11g	6 Mbps OFDM	_	-95.0	_	dBm
(10% PER for 1024 octet PSDU)	9 Mbps OFDM	_	-93.8	_	dBm
	12 Mbps OFDM	_	-92.7	_	dBm
	18 Mbps OFDM	_	-90.3	_	dBm
	24 Mbps OFDM	-	-87.1	_	dBm
	36 Mbps OFDM	-	-83.6	_	dBm
	48 Mbps OFDM	_	-79.3	_	dBm
	54 Mbps OFDM	_	-78.0	_	dBm
RX sensitivity IEEE 802.11n	20 MHz channel spacing for all MCS rates	- I		l	
(10% PER for 4096 octet PSDU) 1	MCS0	_	-94.6	_	dBm
Defined for default parameters: 800 ns GI and non-STBC.	MCS1	_	-92.1	_	dBm
	MCS2	_	-89.8	_	dBm
	MCS3	_	-86.6	_	dBm
	MCS4	_	-83.0	_	dBm
	MCS5	-	-78.3	_	dBm
	MCS6	_	-76.6	_	dBm
	MCS7	_	-75.0	_	dBm
Input in-band IP3	Maximum LNA gain	-	-8	_	dBm
	Minimum LNA gain	_	+9	_	dBm
Maximum receive level @ 2.4 GHz	@ 1, 2 Mbps (8% PER, 1024 octets)	-3.5	-	_	dBm
	@ 5.5, 11 Mbps (8% PER, 1024 octets)	-9.5	_	_	dBm
	@ 6, 9, 12 Mbps (10% PER, 1024 octets)	-9.5	_	_	dBm
	@ MCS0-2 rates (10% PER, 4095 octets)	-9.5	_	_	dBm
	@ 18, 24, 36, 48, 54 Mbps (10% PER, 1024 octets)	-14.5	_	-	dBm
	@ MCS3-7 rates (10% PER, 4095 octets)	-14.5	_	-	dBm



Table 20. WLAN 2.4 GHz Receiver Performance Specifications (Cont.)

Parameter	Conditio	n/Notes	Minimum	Typical	Maximum	Unit	
Adjacent channel rejection-DSSS		Desired and interfering signal 30 MHz apart					
(Difference between interfering and desired signal at 8% PER for	1 Mbps DSSS	–74 dBm	35	_	_	dB	
1024 octet PSDU with desired signal level as specified in	2 Mbps DSSS	–74 dBm	35	_	_	dB	
Condition/Notes.)		Desired and interfering signal 25 MHz apart					
	5.5 Mbps DSSS	-70 dBm	35	_	_	dB	
	11 Mbps DSSS	-70 dBm	35	_	_	dB	
Adjacent channel rejection-OFDM	6 Mbps OFDM	–79 dBm	16	_	_	dB	
(Difference between interfering and desired signal (25 MHz apart)	9 Mbps OFDM	–78 dBm	15	_	_	dB	
at 10% PER for 1024 octet PSDÚ	12 Mbps OFDM	–76 dBm	13	_	_	dB	
with desired signal level as specified in Condition/Notes.)	18 Mbps OFDM	–74 dBm	11	_	_	dB	
openios in Constitution (140tos.)	24 Mbps OFDM	–71 dBm	8	_	_	dB	
	36 Mbps OFDM	–67 dBm	4	_	_	dB	
	48 Mbps OFDM	–63 dBm	0	_	_	dB	
	54 Mbps OFDM	–62 dBm	- 1	_	_	dB	
Adjacent channel rejection MCS0-	MCS0	–79 dBm	16	_	_	dB	
7 (Difference between interfering	MCS1	–76 dBm	13	_	_	dB	
and desired signal (25 MHz apart)	MCS2	–74 dBm	11	_	_	dB	
at 10% PER for 4096 octet PSDU with desired signal level as	MCS3	–71 dBm	8	_	_	dB	
specified in Condition/Notes.)	MCS4	–67 dBm	4	_	_	dB	
	MCS5	–63 dBm	0	_	_	dB	
	MCS6	–62 dBm	-1	_	_	dB	
	MCS7	–61 dBm	-2	_	_	dB	
Maximum receiver gain	_	_	_	66	_	dB	
Gain control step	_	_	_	3	_	dB	
RSSI accuracy ²	Range –95 ³ dBm to –	-30 dBm	-5	_	5	dB	
	Range above -30 dBi	m	-8	_	8	dB	
Return loss	$Z_0 = 50\Omega$, across the	dynamic range	10	11.5	13	dB	
Receiver cascaded noise figure	At maximum gain			4	_	dB	

^{1.} Sensitivity degradations for alternate settings in MCS modes. MM: 0.5 dB drop, and SGI: 2 dB drop.

^{2.} The minimum and maximum values shown have a 95% confidence level.

^{3.} -95 dBm with calibration at time of manufacture, -92 dBm without calibration.



14.4 WLAN 2.4 GHz Transmitter Performance Specifications

Note: Unless otherwise noted, the values shown in Table 21 apply at the chip ports.

Table 21. WLAN 2.4 GHz Transmitter Performance Specifications

Parameter	Condition/N	otes	Minimum	Typical	Maximum	Unit
Frequency range	_		2400	_	2500	MHz
RF port TX power EVM ¹	DSS/CCK	−9 dB	_	20.5	-	dBm
(highest power setting, 25°C, and	OFDM, BPSK	–8 dB	_	20	-	dBm
VBAT = 3.6)	OFDM, QPSK	–13 dB	_	20	_	dBm
	OFDM, 16-QAM	–19 dB	_	19	_	dBm
	OFDM, 64-QAM (R = 3/4)	–25 dB	-	19	_	dBm
	OFDM, 64-QAM (MCS7, HT20)	–27 dB	_	18.5	_	dBm
OFDM EVM ²	OFDM, BPSK	5 dBm	-29	-31	_	dB
(25°C, VBAT = 3.6V)	OFDM, 64-QAM	5 dBm	-31	-33	-	dB
	MCS7	5 dBm	-33	-35	_	dB
Phase noise	37.4 MHz crystal, integrat 10 MHz	ed from 10 kHz to	_	0.45	_	Degrees
TX power control dynamic range	_		10	_	_	dB
Closed-loop TX power variation at highest power level setting	Across full temperature and voltage range. Applies to 10 dBm to 20 dBm output power range.		_	-	±1.5	dB
Carrier suppression	-		15	_	-	dBc
Gain control step	_		_	0.25	-	dB
Return loss at Chip port TX	$Z_{o} = 50\Omega$		_	6	_	dB

^{1.} This specification row indicates the linear power specification as measured from the chip output port. The requirement is in dBm (TX power). The ratio (dB) in the Conditions/Notes column is the EVM.

Document Number: 002-14826 Rev. *G Page 47 of 65

^{2.} This specification row indicates the EVM floor. The requirement is in dB (EVM). The power in the Conditions/Notes column is the TX power specification in dBm.



14.5 General Spurious Emissions Specifications

This section provides the TX and RX spurious emissions specifications for the WLAN 2.4 GHz band. The recommended spectrum analyzer settings for the spurious emissions specifications are provided in Table 22.

Table 22. Recommended Spectrum Analyzer Settings

Parameter	Setting
Resolution bandwidth (RBW)	1 MHz
Video bandwidth (VBW)	1 MHz
Sweep	Auto
Span	100 MHz
Detector	Maximum peak
Trace	Maximum hold
Modulation	OFDM

14.5.1 Transmitter Spurious Emissions Specifications

2.4 GHz Band Spurious Emissions

20-MHz Channel Spacing

Note: Possible AFE combinations are as follows. The AFE=VCO/18 specifications for channel 2442 are listed in Table 23

Table 23. 2.4 GHz Band, 20-MHz Channel Spacing TX Spurious Emissions Specifications

2G - 20 MHz E	2G - 20 MHz BW	
Emissions Frequency Range (MHz)	Channel Power (dBm)	CH2442
1000-2000	21	-50
2000-2400	21	-40
2500-3000	21	-40
3000-4000	21	-39
4000-5000	21	-24
5000-6000	21	-48
6000-7000	21	-49
7000-8000	21	-13
8000-10000	21	-43
10000-12000	21	-52
12000-15000	21	-50
15000-20000	21	-49

14.5.2 Receiver Spurious Emissions Specifications

Table 24. 2G General Receiver Spurious Emissions

Band	Frequency Range	Typical	Maximum	Unit
2G	2.4 GHz < f < 2.5 GHz	-75.5	-74.1	dBm
	3.6 GHz < f < 3.8 GHz	-52.8	-50.9	dBm

Document Number: 002-14826 Rev. *G Page 48 of 65



15. Internal Regulator Electrical Specifications

15.1 Core Buck Switching Regulator

Note: Values in this data sheet are design goals and are subject to change based on device characterization results.

Note: Functional operation is not guaranteed outside of the specification limits provided in this section.

Table 25. Core Buck Switching Regulator (CBUCK) Specifications

Specification	Notes	Min.	Тур.	Max.	Unit
Input supply voltage (DC)	DC voltage range inclusive of disturbances.	3.0	3.6	4.8 ¹	V
PWM mode switching frequency	CCM, load > 100 mA VBAT = 3.6V.	_	4	-	MHz
PWM output current	-	-	-	550	mA
Output current limit	-	-	1400	-	mA
Output voltage range	Programmable, 30 mV steps. Default = 1.35V.	1.2	1.35	1.5	V
PWM output voltage DC accuracy	Includes load and line regulation. Forced PWM mode.	-4	-	4	%
PWM ripple voltage, static	Measure with 20 MHz bandwidth limit. Static load. Max. ripple based on VBAT = 3.6V, Vout = 1.35V, Fsw = 4 MHz, 2.2 μ H inductor with min. effective L > 1.05 μ H, cap. + board total – ESR < 20 m Ω , C_{out} > 1.9 μ F, ESL<200 pH	_	7	20	mVpp
PWM mode peak efficiency	Peak efficiency at 200 mA load.	78	86	_	%
PFM mode efficiency	10 mA load current.	70	81	-	%
Start-up time from power down	VIO already ON and steady. Time from REG_ON rising edge to CLDO reaching 1.2V.	-	400	500	μs
External inductor	0806 size, 2.2 μH, DCR = 0.11 Ω , ACR = 1.18 Ω @ 4 MHz.	-	2.2	_	μH
External output capacitor	Ceramic, X5R, 0402, ESR <30 m Ω at 4 MHz, 4.7 μ F ±20%, 6.3V.	2.0 ²	4.7	10 ³	μF
External input capacitor	For SR_VDDBAT5V pin, ceramic, X5R, 0603, ESR < 30 m Ω at 4 MHz, ±4.7 μ F ±20%, 6.3V.	0.67 ²	4.7	_	μF
Input supply voltage ramp-up time	0 to 4.3V.	40	_	_	μs

^{1.} The maximum continuous voltage is 4.8V. Voltages up to 6.0V for up to 10 seconds, cumulative duration, over the lifetime of the device are allowed. Voltages as high as 5.0V for up to 250 seconds, cumulative duration, over the lifetime of the device are allowed.

^{2.} Minimum capacitor value refers to the residual capacitor value after taking into account the part-to-part tolerance, DC-bias, temperature, and aging.

^{3.} Total capacitance includes those connected at the far end of the active load.



15.2 3.3V LDO (LDO3P3)

Table 26. LDO3P3 Specifications

Specification	Notes	Min.	Тур.	Max.	Units
Input supply voltage, V _{in}	Min. = V_0 + 0.2V = 3.5V dropout voltage requirement must be met under maximum load for performance specifications.	3.0	3.6	4.8 ¹	V
Output current	-	0.001	_	450	mA
Nominal output voltage, V _o	Default = 3.3V.	_	3.3	_	٧
Dropout voltage	At max. load.	_	_	200	mV
Output voltage DC accuracy	Includes line/load regulation.	- 5	_	+5	%
Quiescent current	No load.	_	_	85	μA
Line regulation	V _{in} from (V _o + 0.2V) to 4.8V, max. load.	_	_	3.5	mV/V
Load regulation	Load from 1 mA to 450 mA.	_	_	0.3	mV/mA
PSRR	$V_{in} \ge V_o + 0.2V$, $V_o = 3.3V$, $C_o = 4.7 \mu F$, Max load, 100 Hz to 100 kHz.	20	_	_	dB
LDO turn-on time	Chip already powered up.	_	160	250	μs
External output capacitor, C _o	Ceramic, X5R, 0402,(ESR: 5 m Ω –240 m Ω), ± 10%, 10V.	1.0 ²	4.7	10	μF
External input capacitor	For LDO_VDDBAT5V pin (shared with band gap) ceramic, X5R, 0402, (ESR: $30m\Omega-200~m\Omega$), $\pm~10\%$, 10V. Not needed if sharing 4.7 µF VBAT capacitor with SR_VDDBAT5V.	-	4.7	_	μF

^{1.} The maximum continuous voltage is 4.8V. Voltages up to 6.0V for up to 10 seconds, cumulative duration, over the lifetime of the device are allowed. Voltages as high as 5.0V for up to 250 seconds, cumulative duration, over the lifetime of the device are allowed.

^{2.} Minimum capacitor value refers to the residual capacitor value after taking into account the part-to-part tolerance, DC-bias, temperature, and aging.



15.3 CLDO

Table 27. CLDO Specifications

Specification	Notes	Min.	Тур.	Max.	Units
Input supply voltage, V _{in}	Min. = 1.2 + 0.15V = 1.35V dropout voltage requirement must be met under maximum load.	1.3	1.35	1.5	٧
Output current	-	0.2	_	350	mA
Output voltage, V _o	Programmable in 10 mV steps. Default = 1.2.V.	0.95	1.2	1.26	٧
Dropout voltage	At max. load.	_	_	150	mV
Output voltage DC accuracy	Includes line/load regulation.	-4	_	+4	%
Quiescent current	No load.	-	26	_	μA
	200 mA load.	_	2.48	_	mA
Line regulation	V _{in} from (V _o + 0.15V) to 1.5V, maximum load.	_	_	5	mV/V
Load regulation	Load from 1 mA to 300 mA.	_	0.02	0.05	mV/mA
Leakage current	Power down.	_	10	40	μA
	Bypass mode.	_	2	6	μA
PSRR	@1 kHz, Vin ≥ 1.35V, C_0 = 4.7 μ F.	20	_		dB
Start-up time of PMU	VIO up and steady. Time from the REG_ON rising edge to the CLDO reaching 1.2V.	-	_	700	μs
LDO turn-on time	LDO turn-on time when the rest of the chip is up.	_	140	180	μs
External output capacitor, C _o	Total ESR: 5 m Ω –240 m Ω .	3.76 ¹	4.7	_	μF
External input capacitor	Only use an external input capacitor at the LDO_VDD1P5 pin if it is not supplied from the CBUCK output.	-	1	2.2	μF

^{1.} Minimum capacitor value refers to the residual capacitor value after taking into account the part-to-part tolerance, DC-bias, temperature, and aging.



15.4 LNLDO

Table 28. LNLDO Specifications

Specification	Notes	Min.	Тур.	Max.	Units
Input supply voltage, Vin	Min. $V_{IN} = V_O + 0.15V = 1.35V$ (where $V_O = 1.2V$)dropout voltage requirement must be met under maximum load.	1.3	1.35	1.5	V
Output current	-	0.1	_	150	mA
Output voltage, V _o	Programmable in 25 mV steps. Default = 1.2V.	1.1	1.2	1.275	V
Dropout voltage	At maximum load.	_	_	150	mV
Output voltage DC accuracy	Includes line/load regulation.	-4	_	+4	%
Quiescent current	No load.	_	44	_	μΑ
	Max. load.	_	970	990	μΑ
Line regulation	V _{in} from (V _o + 0.1V) to 1.5V, 150 mA load.	_	_	5	mV/V
Load regulation	Load from 1 mA to 150 mA.	_	0.02	0.05	mV/ mA
Leakage current	Power-down.	_	_	10	μΑ
Output noise	@30 kHz, 60–150 mA load $C_{\rm o}$ = 2.2 µF. @100 kHz, 60–150 mA load $C_{\rm o}$ = 2.2 µF.	_	-	60 35	nV/rt Hz nV/ rt Hz
PSRR	@ 1kHz, Input > 1.35V, C_0 = 2.2 μ F, V_0 = 1.2V.	20	-	-	dB
LDO turn-on time	LDO turn-on time when the rest of the chip is up.	_	140	180	μs
External output capacitor, C_o	Total ESR (trace/capacitor): 5 m Ω –240 m Ω .	0.5 ¹	2.2	4.7	μF
External input capacitor	Only use an external input capacitor at the LDO_VDD1P5 pin if it is not supplied from the CBUCK output. Total ESR (trace/capacitor): 30 m Ω –200 m Ω .	_	1	2.2	μF

^{1.} Minimum capacitor value refers to the residual capacitor value after taking into account the part-to-part tolerance, DC-bias, temperature, and aging.



15.5 BBPLL LDO

Table 29. BBPLL LDO Specifications

Parameter	Conditions and Comments	Min.	Тур.	Max.	Units
Input supply voltage, V _{in}	Min. $V_{in} = V_o + 0.15V = 1.35V$ (for $V_o = 1.2V$).	1.3	1.35	1.5	V
	The dropout voltage requirement must be met under maximum load.				
Output voltage, V _o	Programmable in 25 mV steps. Default = 1.2V.	1.1	1.2	1.275	٧
Dropout voltage	At max. load	_	_	150	mV
Output voltage DC accuracy	Includes line/load regulation.	-4	-	+4	%
Output current	Peak load = 80 mA, average = 35 mA	0.1	_	55	mA
Quiescent current	No load	_	10	12	μΑ
	55 mA load	_	550	570	μΑ
Line regulation	V _{in} from (V _o + 0.15V) to 1.5V; 200 mA load	_	_	5	mV/V
Load regulation	load from 1mA to 200 mA; V _{in} ≥ (V _o + 0.15V)	_	0.025	0.045	mV/mA
Leakage current	Powered down. Junction temperature is 85°C.	-	5	20	μΑ
	Bypass mode	_	0.2	1.5	μΑ
PSRR	@1 kHz, $V_{in} \ge V_o + 0.15V$, Co = 4.7 μ F	20	_	-	dB
Start-up time of PMU	VIO up and steady. Time from REG_ON rising edge to CLDO reaching 99% of $\rm V_o$.	_	530	700	us
LDO turn-on time	The LDO turn-on time when the rest of the chip is up.	_	140	180	us
Inrush current	Vin=Vo+0.15V to 1.5V, Co=0.47uF, no load	_	60	70	mA
External output capacitor, C _o	Ceramic, X5R, size 0201, max. 6.3V, 20% tolerance	0.27	0.47	-	μF
External input capacitor	Only use an external input capacitor at the LDO_VDD1P5 pin if it is not supplied from the CBUCK output.	-	1	-	μF



16. System Power Consumption

Note: Values in this data sheet are design goals and are subject to change based on the results of device characterization.

Note: Unless otherwise stated, these values apply for the conditions specified in Table 16, "Recommended Operating Conditions and DC Characteristics,".

16.1 WLAN Current Consumption

The tables in this subsection show the typical, total current used by the CYW43903. Current values may be measured with the APPS core powered off. The first column of the table, the mode description, will state the power condition of the APPS core.

16.1.1 2.4 GHz Mode

Table 30. 2.4 GHz Mode WLAN Current Consumption

Mode	V _{BAT} = 3.6V ¹ (μA)	VDDIO = VDDIO_HIB = 3.3V ^{1, 2} (μA)			
Sleep Mode	s				
Radio off ³	3	3			
Sleep ^{4, 5}	6	160			
IEEE Power Save, DTIM=1, single RX, APPS powered down ⁶	2180	160			
IEEE Power Save, DTIM=3, single RX, APPS powered down ⁷	680	160			
IEEE Power Save, DTIM=9, single RX, APPS powered down	233	160			
Active Mode	s				
Continuous RX mode MCS7, HT20, 1SS, APPS powered up ^{8, 9}	57,200	60			
CRS-HT20, APPS powered up ¹⁰	55,200	60			
Continuous TX mode 1 Mbps, APPS powered up ¹¹	325,000	60			
Continuous TX mode MCS7, HT20, 1SS, 1 TX, APPS powered up ¹²	302,000	60			
Ping Modes					
Ping to associated access point ¹¹	336,000	60			
Sleep	6	160			

- 1. Typical silicon.
- 2. VIO is specified with all pins idle (not switching) and not driving any loads.
- 3. REG_ON is low or the device is in hibernation, and all supplies are present.
- 4. REG_ON is high. APPS domain is powered down. WLAN domain is in low-power state retention mode. Top level is powered up.
- 5. Inter-beacon current.
- 6. Beacon Interval = 102.4 ms. Beacon duration = 1 ms @ 1 Mbps. Average current over 3× DTIM intervals.
- 7. Beacon interval = 307.2 ms. Beacon duration = 1 ms @ 1 Mbps. Average current over 3× DTIM intervals.
- 8. Duty cycle is 100%. Carrier sense (CS) detect/packet receive.
- 9. Measured using packet engine test mode.
- 10. Carrier sense (CCA) when no carrier present.
- 11. Duty cycle is 100%. TX power at chip output ~17.7 dBm.
- 12. Duty cycle is 100%. TX power at chip output ~15.2 dBm.

Document Number: 002-14826 Rev. *G Page 54 of 65



17. SPI Flash Characteristics

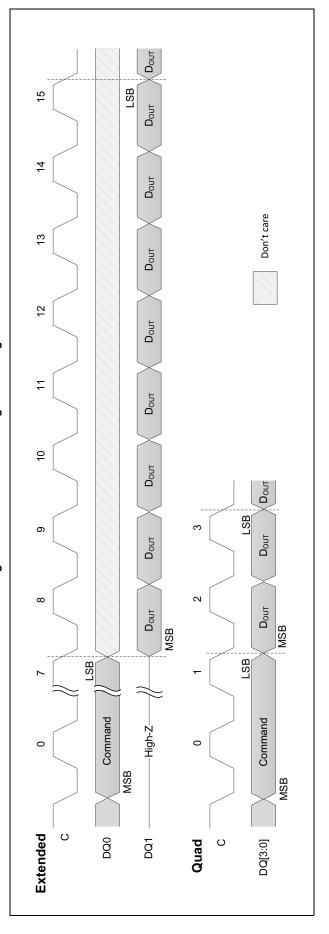
17.1 SPI Flash Timing

17.1.1 Read-Register Timing

Figure 13 shows the SPI flash extended and quad read-register timing.

Note: Regarding Figure 13: All Read Register commands except Read Lock Register are supported. A Read Nonvolatile Configuration Register operation will output data starting from the least significant byte.

Figure 13. SPI Flash Read-Register Timing



Page 55 of 65



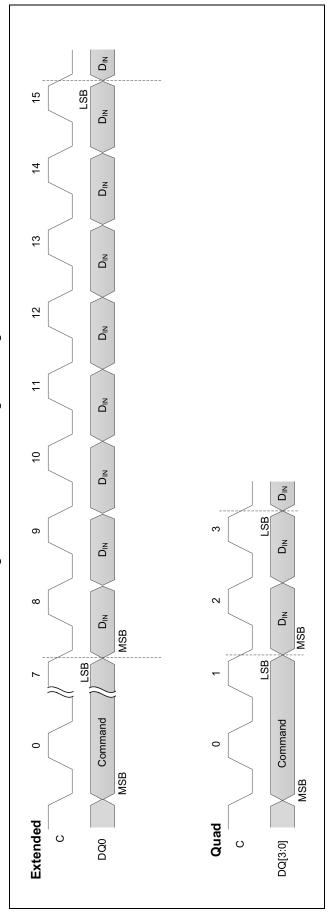
17.1.2 Write-Register Timing

Figure 14 shows the SPI flash extended and quad write-register timing.

Note: Regarding Figure 14:

- 1. All write-register commands except Write Lock Register are supported.
- The waveform must be extended for each protocol: to 23 for extended and five for quad. 2
- A Write Nonvolatile Configuration Register operation requires data being sent starting from the least significant byte. რ

Figure 14. SPI Flash Write-Register Timing



Page 56 of 65



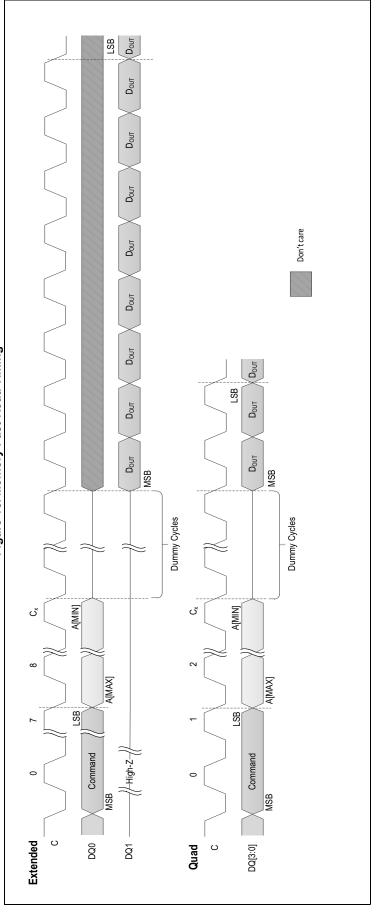
17.1.3 Memory Fast-Read Timing

Figure 15 shows the SPI flash extended and quad memory fast-read timing.

Note: Regarding Figure 15:

- 1. 24-bit addressing is used, so A[MAX] = A[23] and A[MIN] = A[0].
- 2. For an extended SPI protocol, $C_x = 7 + (A[MAX] + 1)$.
- 3. For a quad SPI protocol, $C_x = 1 + (A[MAX] + 1)/4$.

Figure 15. Memory Fast-Read Timing



Page 57 of 65



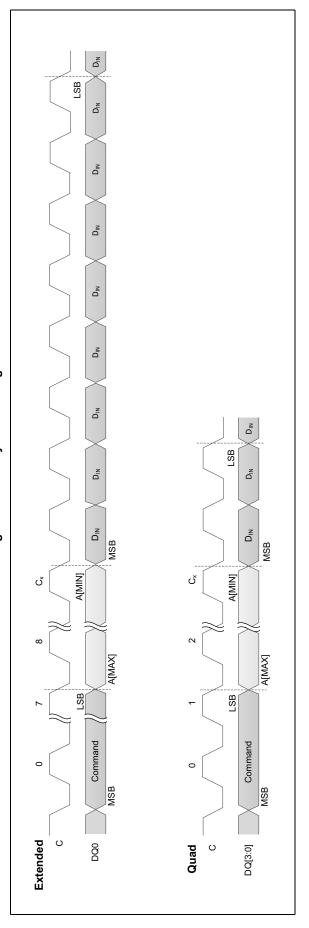
17.1.4 Memory-Write Timing

Figure 16 shows the SPI flash extended and quad memory-write (Page Program) timing.

Note: Regarding Figure 16:

- 1. For an extended SPI protocol, $C_x = 7 + (A[MAX] + 1)$.
- 2. For a quad SPI protocol, $C_x = 1 + (A[MAX] + 1)/4$.

Figure 16. Memory-Write Timing



Page 58 of 65



17.1.5 SPI Flash Parameters

The combination of Figure 17 and Table 31 provide the SPI flash timing parameters.

Figure 17. SPI Flash Timing Parameters Diagram

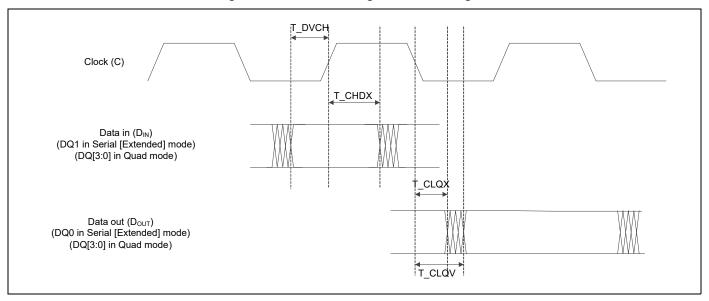


Table 31. SPI Flash Timing Parameters

Parameter	Description	Minimum	Maximum	Units
T_DVCH	Data setup time	2	_	ns
T_CHDX	Data hold time	3	_	ns
T_CLQX	Output hold time	1	_	ns
T_CLQV	Output valid time (with a 10 pF load)	_	5	ns



18. Power-Up Sequence and Timing

18.1 Sequencing of Reset and Regulator Control Signals

The CYW43903 has two signals that allow the host to control power consumption by enabling or disabling the internal regulator blocks. These signals are described below. Additionally, diagrams are provided to indicate proper sequencing of the signals for various operational states (see Figure 18 and Figure 19). The timing values indicated are minimum required values; longer delays are also acceptable.

18.1.1 Description of Control Signals

- **REG_ON**: Used by the PMU to power-up the CYW43903. It controls the internal CYW43903 regulators. When this pin is high, the regulators are enabled and the device is out of reset. When this pin is low the regulators are disabled.
- HIB_REG_ON_IN: Used by the Hibernation (HIB) block to power up the internal CYW43903 regulators. If the HIB_REG_ON_IN pin is low, the regulators are disabled. For the HIB_REG_ON_IN pin to work as designed, HIB_REG_ON_OUT must be connected to REG_ON.

Note: The CYW43903 has an internal power-on reset (POR) circuit. The device will be held in reset for a maximum of 110 ms after VDDC and VDDIO have both passed the POR threshold.

Note: The 10%–90% VBAT rise time should not be faster than 40 microseconds. VBAT should be up before or at the same time as VDDIO. VDDIO should not be present first or be held high before VBAT is high.

18.1.2 Control Signal Timing Diagrams

Figure 18. REG_ON = High, No HIB_REG_ON_OUT Connection to REG_ON

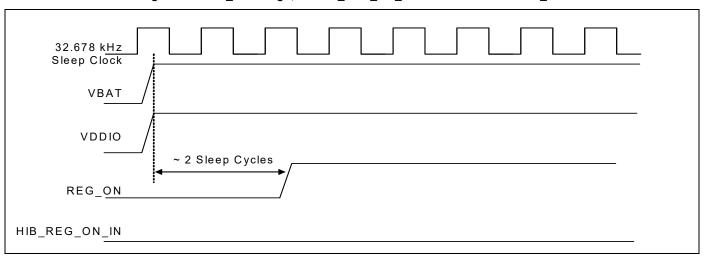
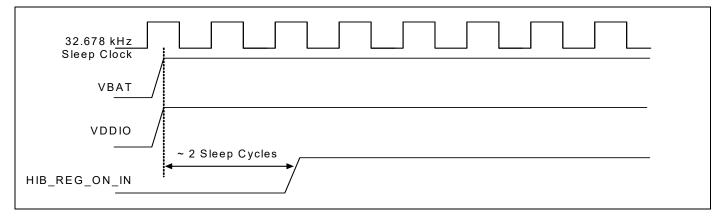


Figure 19. HIB_REG_ON_IN = High, HIB_REG_ON_OUT Connected to REG_ON





19. Thermal Information

19.1 Package Thermal Characteristics

Table 32. Package Thermal Characteristics¹

Characteristic	WLBGA
θ _{JA} (°C/W) (value in still air)	31.72
θ _{JB} (°C/W)	3.95
θ _{JC} (°C/W)	2.16
Ψ _{JT} (°C/W)	4.3
Ψ _{JB} (°C/W)	9.28
Maximum Junction Temperature T _j (°C)	113.9
Maximum power dissipation (W)	1.38

^{1.} No heat sink, TA = 70°C. This is an estimate based on a 4-layer PCB that conforms to EIA/JESD51-7. Air velocity is 0 m/s.

19.2 Junction Temperature Estimation and PSI_{JT} Versus THETA_{JC}

Package thermal characterization parameter PSI-J_T (Ψ_{JT}) yields a better estimation of actual junction temperature (T_{J}) versus using the junction-to-case thermal resistance parameter Theta-J_C (θ_{JC}). The reason for this is that θ_{JC} assumes that all the power is dissipated through the top surface of the package case. In actual applications, some of the power is dissipated through the bottom and sides of the package. Ψ_{JT} takes into account power dissipated through the top, bottom, and sides of the package. The equation for calculating the device junction temperature is:

$$TJ = TT + P \times YJT$$

Where:

- T_J = Junction temperature at steady-state condition (°C)
- T_T = Package case top center temperature at steady-state condition (°C)
- P = Device power dissipation (Watts)
- \(\mathcal{Y}_{\text{IT}} = \text{Package thermal characteristics; no airflow (°C/W)} \)

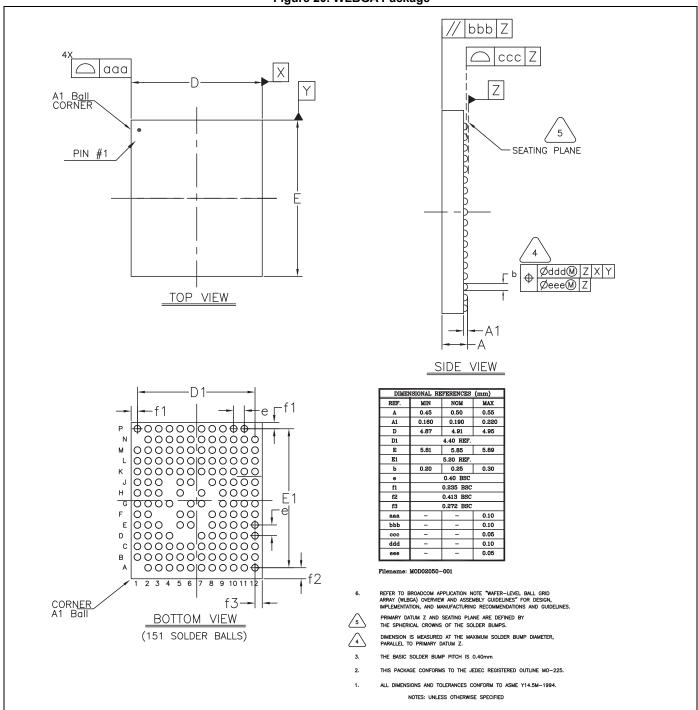
19.3 Environmental Characteristics

For environmental characteristics data, see Table 14, "Environmental Ratings,".



20. Mechanical Information

Figure 20. WLBGA Package





21. Ordering Information

Part Number	Package	Description	Operating Ambient Temperature
CYW43903KUBG	4.91 mm x 5.85 mm, 0.4 mm ball pitch, 151-pin WLBGA	_	-30°C to +85°C

22. Additional Information

22.1 Acronyms and Abbreviations

In most cases, acronyms and abbreviations are defined upon first use. For a more complete list of acronyms and other terms used in Cypress documents, go to: http://www.cypress.com/glossary.

22.2 IoT Resources

Cypress provides a wealth of data at http://www.cypress.com/internet-things-iot to help you to select the right IoT device for your design, and quickly and effectively integrate the device into your design. Cypress provides customer access to a wide range of information, including technical documentation, schematic diagrams, product bill of materials, PCB layout information, and software updates. Customers can acquire technical documentation and software from the Cypress Support Community website (https://community.cypress.com/)

22.3 Errata

- 1. The RTC block has been deprecated from this datasheet in revision *A and later. This block is used by Cypress for internal testing/validation/verification and is not intended for customers to use.
- 2. The details of the SPI hardware blocks was not available in revision *E and 5.7 SPI has been added in Revision *F.

 Note that the SPI hardware blocks can only support a hold time of 25ns and a fixed SPI mode (CPHA=0, CPOL = 0). For slaves that require higher hold times or a different mode, a bit banging based SPI driver is recommended.
- 3. The clock for the SPI Flash block needs to be constrained to ~26.67MHz for reliable operation at high operating temperatures. The throughput of the SPI Flash block is therefore restricted to ~13 MBps for Quad mode and ~3 MBps for single mode

Document Number: 002-14826 Rev. *G Page 63 of 65

Page 64 of 65



Document History Page

Revision	ECN	Orig. of Change	Submission Date	Description of Change
** – –	_	10/15/2015	43903-DS100-R	
			Initial Release	
*A	-	_	11/03/2015	43903-DS101-R Updated: Table 21: "Absolute Maximum Ratings", Table 24: "Recommended Operating Conditions and DC Characteristics", Table 30: "WLAN 2.4 GHz Receiver Performance Specifications", Table 31: "WLAN 2.4 GHz Transmitter Performance Specifications"
*B	-	_	03/12/2016	43903-DS102-R Updated: General edits
*C	5445059	UTSV	11/28/2016	Added Cypress Part Numbering Scheme and Mapping Table. Updated to Cypress template.
*D	5593296	TREB	01/24/2017	Removed 43909 Documentation. Updated Cypress Logo and Copyright.
*E	5909757	UTSV	10/12/2017	Updated 512 KB to 1 MB in the following pages: Features on page 1, Figure 1 on page 2, Figure 2 on page 5, Features on page 6, Applications CPU and Memory Subsystem on page 16.
*F	5986964	SHJL	12/11/2017	Updated "Broadcom Serial Control (BSC)" to "Cypress Serial Control (BSC)" throughout the document. Added VBAT in Figure 1 on page 2. Updated the footnotes in Table 4 on page 14. Deleted 3.3 Frequency Selection and Real-Time Clock. Added "Note: JTAG_SEL is exposed on a dedicated physical pin. TAP_SEL uses the GPIO_8 physical pin." below Table 6. Added "Note: The high-speed, 4-wire UART interface is identified as UART0 in this document and in reference schematics. The two low-speed, 2-wire UART interfaces are identified as UART1 and UART2 in this document and in the reference schematics" in the UART on page 18. Added footnote in Table 11 on page 36 and Table 30 on page 54. Added section SPI on page 19. Added Errata on page 63
*G	6026132	SHJL	1/11/2018	Updated footnote of 5.5 SPI Flash as "Note that the clock needs to be constrained to ~26.67MHz for reliable operation at high operating temperatures. The throughput of the SPI Flash block is therefore restricted to ~13 MBps for Quad mode and ~3 MBps for single mode". Added "The clock for the SPI Flash block needs to be constrained to ~26.67MHz for reliable operation at high operating temperatures. The throughput of the SPI Flash block is therefore restricted to ~13 MBps for Quad mode and ~3 MBps for single mode." to 22.3.Errata.



Sales, Solutions, and Legal Information

Worldwide Sales and Design Support

Cypress maintains a worldwide network of offices, solution centers, manufacturer's representatives, and distributors. To find the office closest to you, visit us at Cypress Locations.

cypress.com/mcu

cypress.com/psoc

cypress.com/pmic

cypress.com/touch cypress.com/usb

cypress.com/wireless

Products

Arm® Cortex® Microcontrollers

Automotive

Clocks & Buffers

Interface

Internet of Things

Cypress.com/automotive

cypress.com/clocks

cypress.com/interface

cypress.com/iot

cypress.com/memory

Microcontrollers

PSoC

Power Management ICs
Touch Sensing

USB Controllers
Wireless Connectivity

PSoC[®]Solutions

PSoC 1 | PSoC 3 | PSoC 4 | PSoC 5LP| PSoC 6

Cypress Developer Community

Forums | WICED IOT Forums | Projects | Video | Blogs | Training | Components

Technical Support

cypress.com/support

© Cypress Semiconductor Corporation, 2015-2018. This document is the property of Cypress Semiconductor Corporation and its subsidiaries, including Spansion LLC ("Cypress"). This document, including any software or firmware included or referenced in this document ("Software"), is owned by Cypress under the intellectual property laws and treaties of the United States and other countries worldwide. Cypress reserves all rights under such laws and treaties and does not, except as specifically stated in this paragraph, grant any license under its patents, copyrights, tredemarks, or other intellectual property rights. If the Software is not accompanied by a license agreement and you do not otherwise have a written agreement with Cypress governing the use of the Software, then Cypress hereby grants you a personal, non-exclusive, nontransferable license (without the right to sublicense) (1) under its copyright rights in the Software (a) for Software provided in source code form, to modify and reproduce the Software solely for use with Cypress hardware products, only internally within your organization, and (b) to distribute the Software in binary code form externally to end users (either directly or indirectly through resellers and distributors), solely for use on Cypress hardware product units, and (2) under those claims of Cypress's patents that are infringed by the Software (as provided by Cypress, unmodified) to make, use, distribute, and import the Software solely for use with Cypress hardware products. Any other use, reproduction, modification, translation, or compilation of the Software is prohibited.

TO THE EXTENT PERMITTED BY APPLICABLE LAW, CYPRESS MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARD TO THIS DOCUMENT OR ANY SOFTWARE OR ACCOMPANYING HARDWARE, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE. No computing device can be absolutely secure. Therefore, despite security measures implemented in Cypress hardware or software products, Cypress does not assume any liability arising out of any security breach, such as unauthorized access to or use of a Cypress product. In addition, the products described in these materials may contain design defects or errors known as errata which may cause the product to deviate from published specifications. To the extent permitted by applicable law, Cypress reserves the right to make changes to this document without further notice. Cypress does not assume any liability arising out of the application or use of any product or circuit described in this document. Any information provided in this document, including any sample design information or programming code, is provided only for reference purposes. It is the responsibility of the user of this document to properly design, program, and test the functionality and safety of any application made of this information and any resulting product. Cypress products are not designed, intended, or authorized for use as critical components in systems designed or intended for the operation of weapons, weapons systems, nuclear installations, life-support devices or systems devices or systems (including resuscitation equipment and surgical implants), pollution control or hazardous substances management, or other uses where the failure of the device or system could cause personal injury, death, or property damage ("Unintended Uses"). A critical component is any component of a device or system whose failure to perform can be reasonably expected to cause the failure of the device or system, or to affect its safety or effectiveness. Cypress is not liable, in whole

Cypress, the Cypress logo, Spansion, the Spansion logo, and combinations thereof, WICED, PSoC, CapSense, EZ-USB, F-RAM, and Traveo are trademarks or registered trademarks of Cypress in the United States and other countries. For a more complete list of Cypress trademarks, visit cypress.com. Other names and brands may be claimed as property of their respective owners.

Document Number: 002-14826 Rev. *G Revised January 11, 2018 Page 65 of 65